

SiPM Characterization for CTA

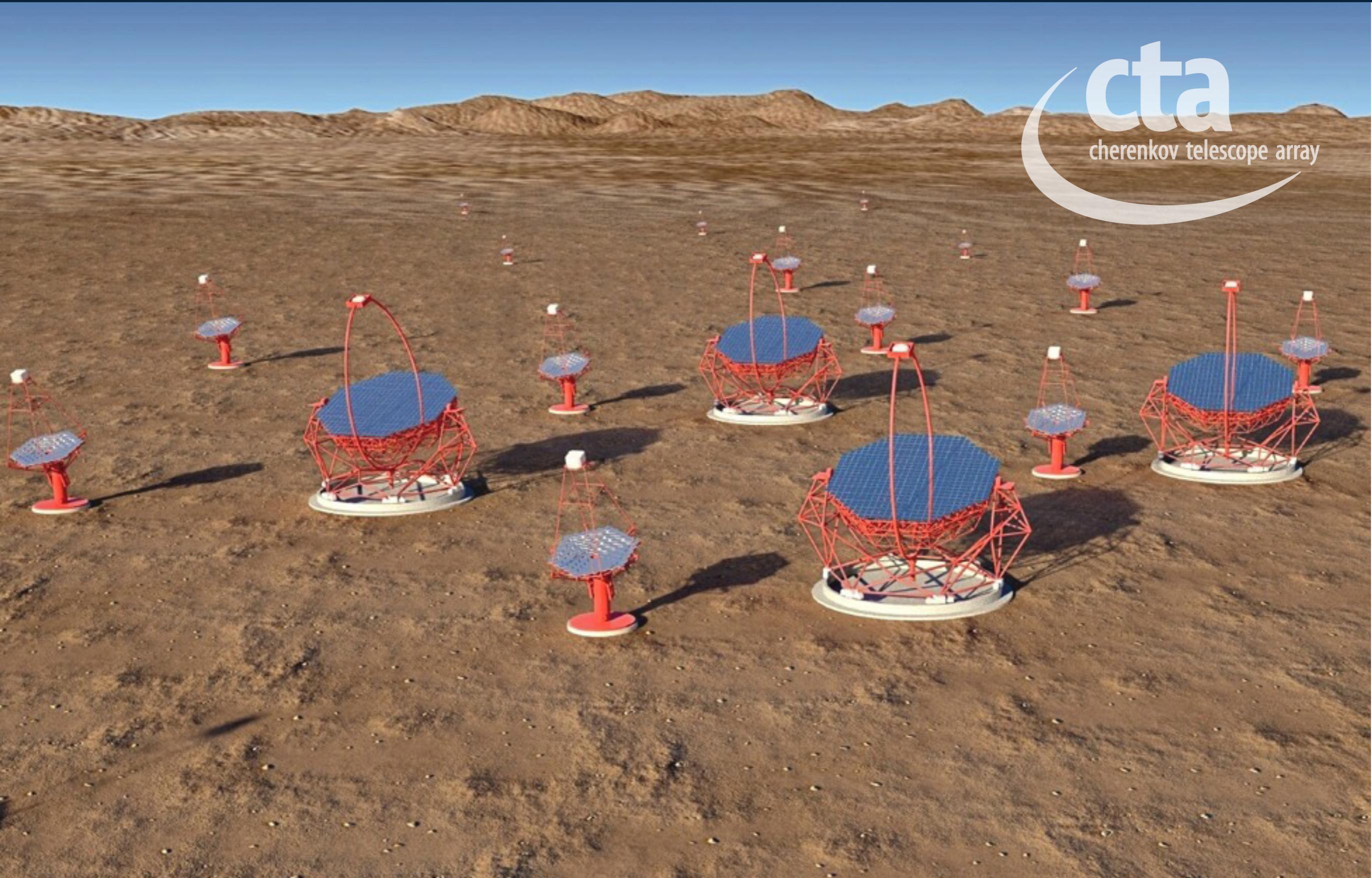
Naoya Hidaka
Nagoya University

SiPM Characterization for CTA

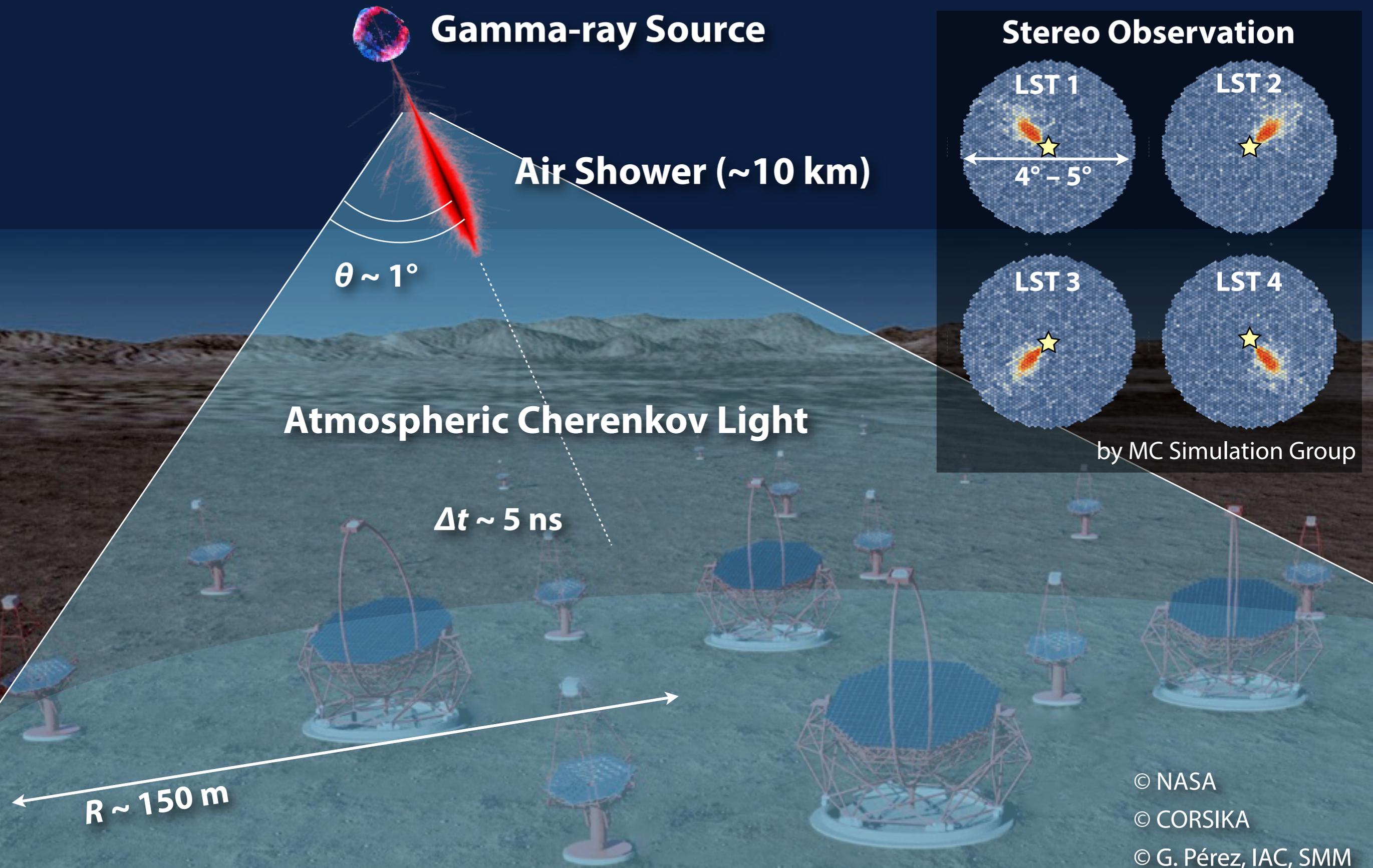
- CTA
- Cherenkov Camera
- SiPM (MPPC) Characterization

Naoya Hidaka
Nagoya University

Cherenkov Telescope Array



Cherenkov Telescope Array



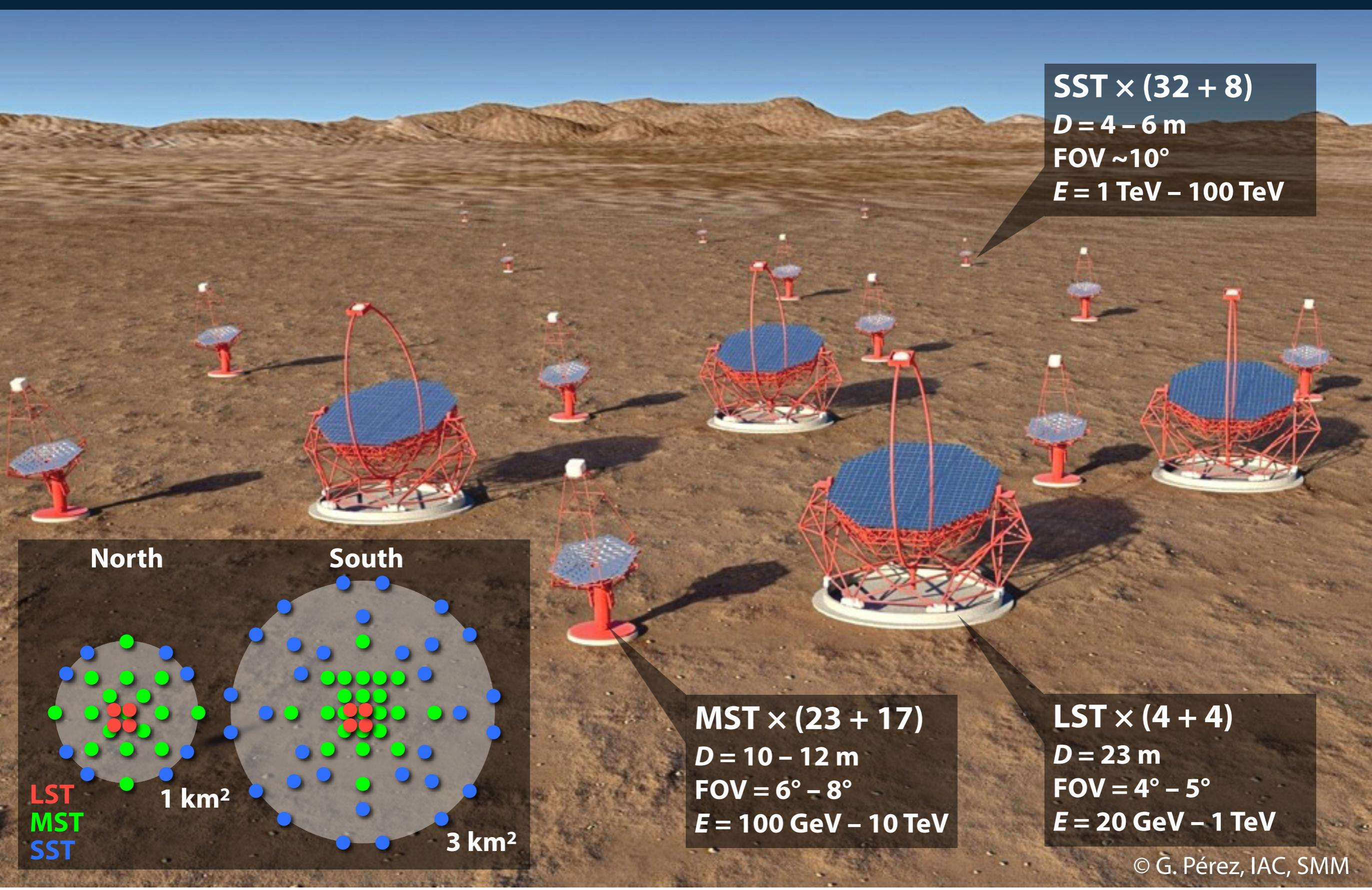
Cherenkov Telescope Array



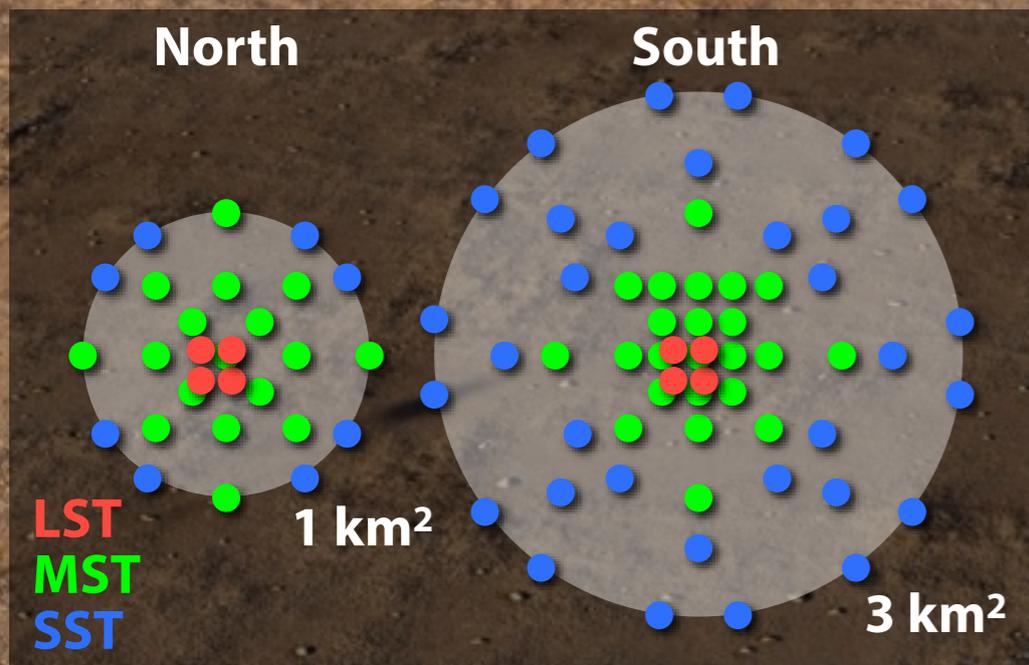
- The Next-generation Very-high-energy (VHE) Gamma-ray Observation
- Energy range of ~ 20 GeV - 100 TeV
- 10-fold increase in sensitivity over current VHE γ -ray instruments
- Large ($\sim 8^\circ$) field of view for surveys
- Improved angular and energy resolution



Cherenkov Telescope Array



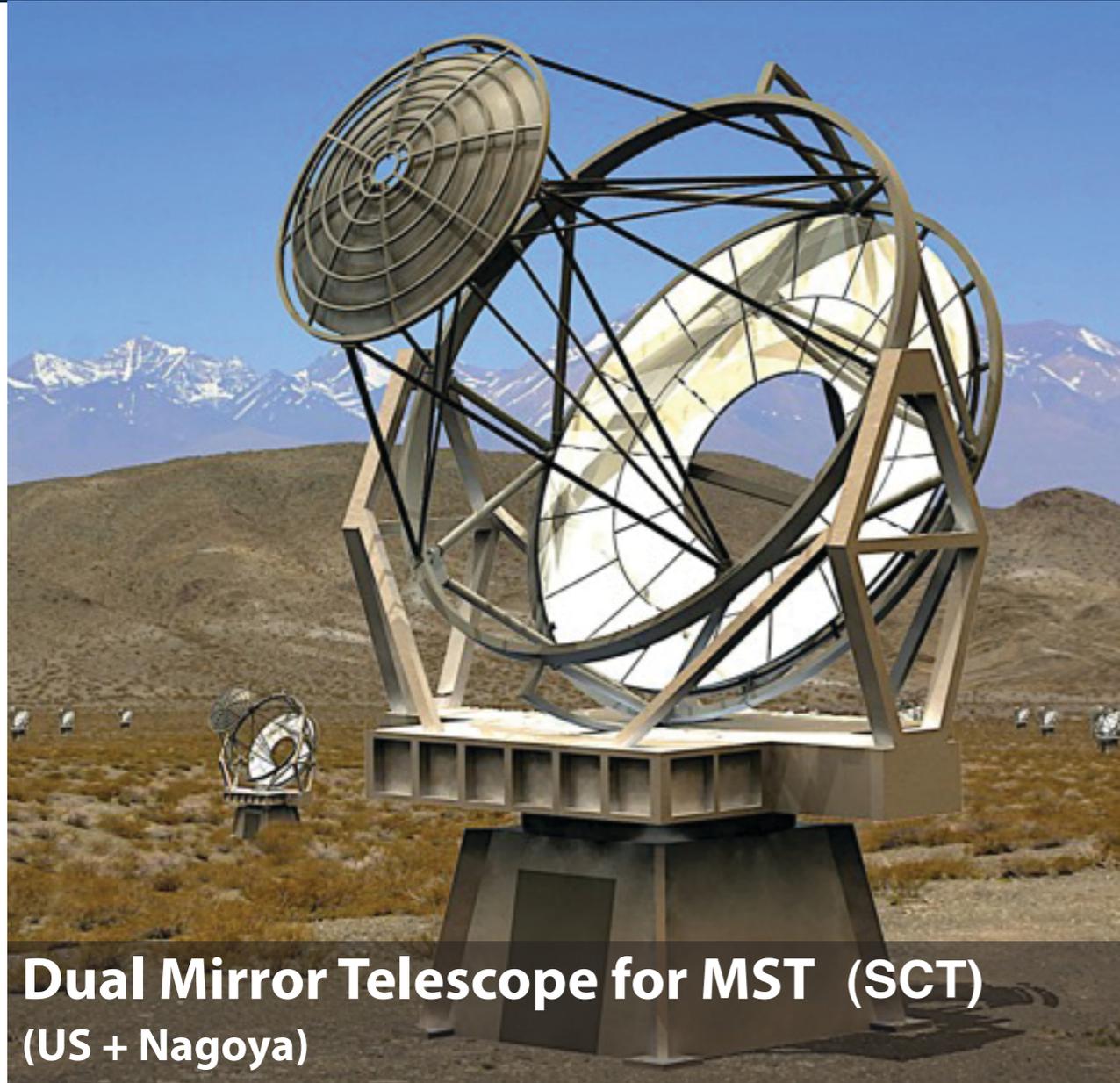
SST × (32 + 8)
D = 4 – 6 m
FOV ~10°
E = 1 TeV – 100 TeV



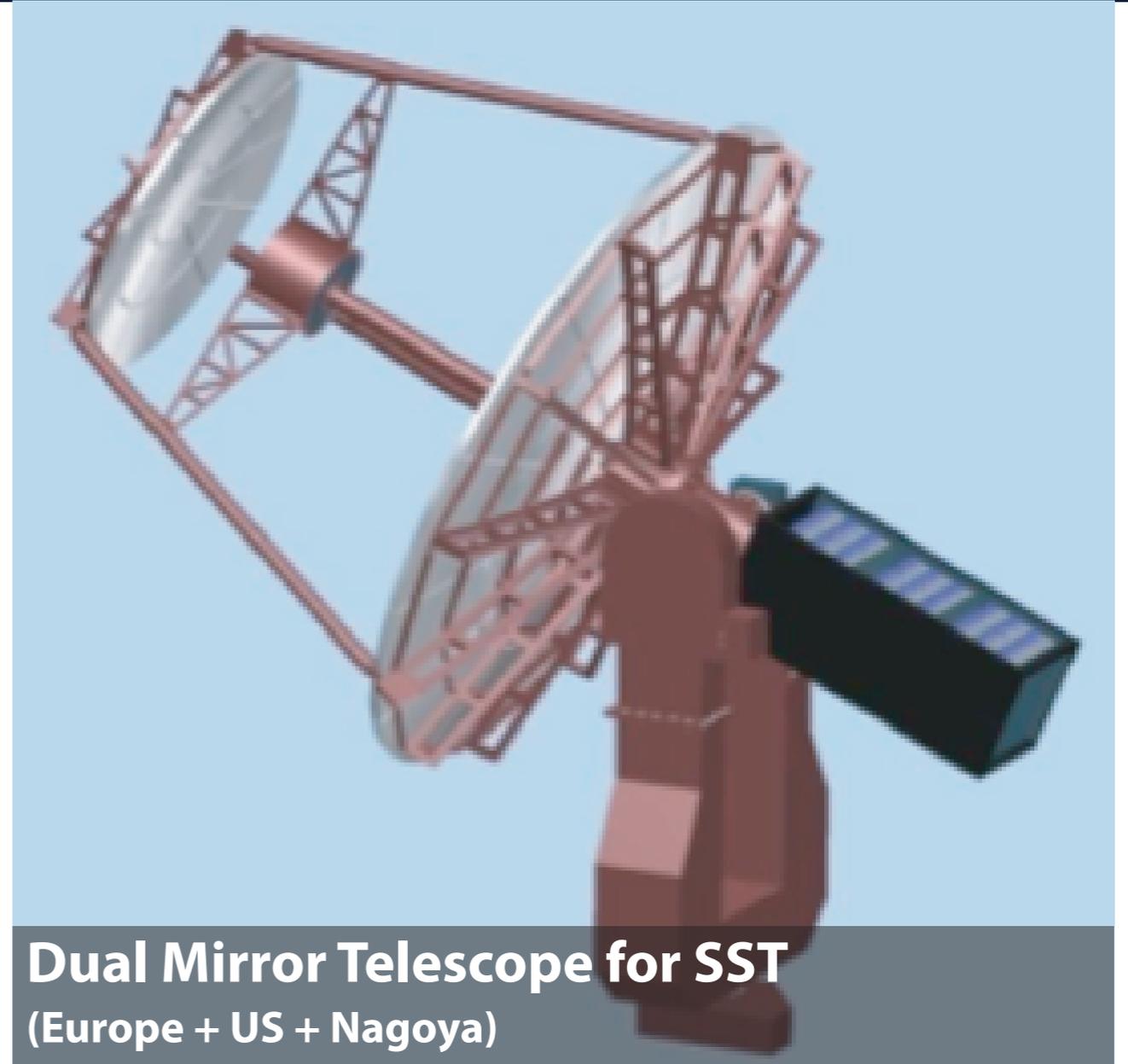
MST × (23 + 17)
D = 10 – 12 m
FOV = 6° – 8°
E = 100 GeV – 10 TeV

LST × (4 + 4)
D = 23 m
FOV = 4° – 5°
E = 20 GeV – 1 TeV

Dual Mirror Telescope



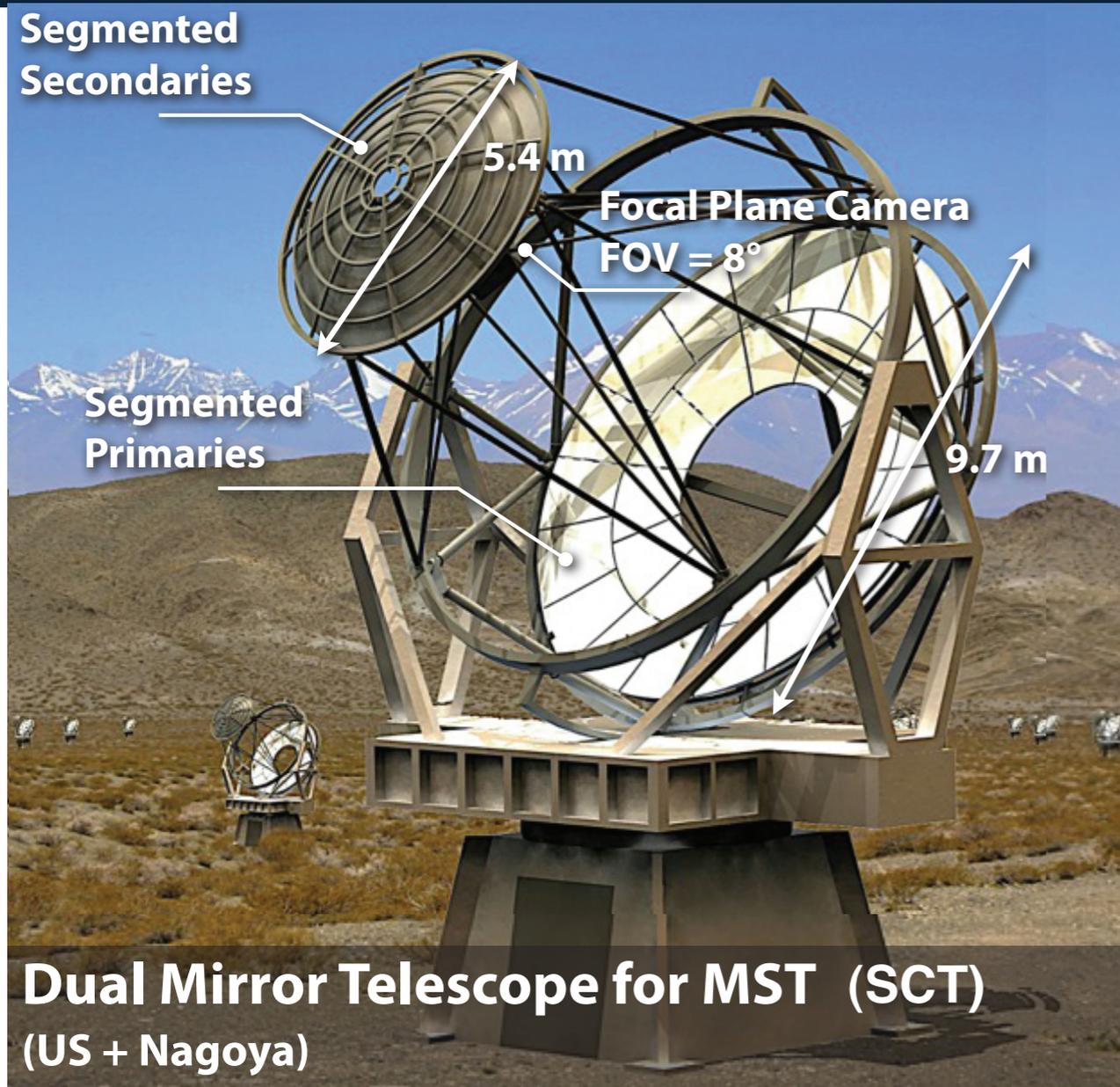
Dual Mirror Telescope for MST (SCT)
(US + Nagoya)



Dual Mirror Telescope for SST
(Europe + US + Nagoya)

- wide FoV, high angular resolution with good off-axis response
- 2-mirror design reduces plate scale allowing multi channel photodetectors and reducing costs

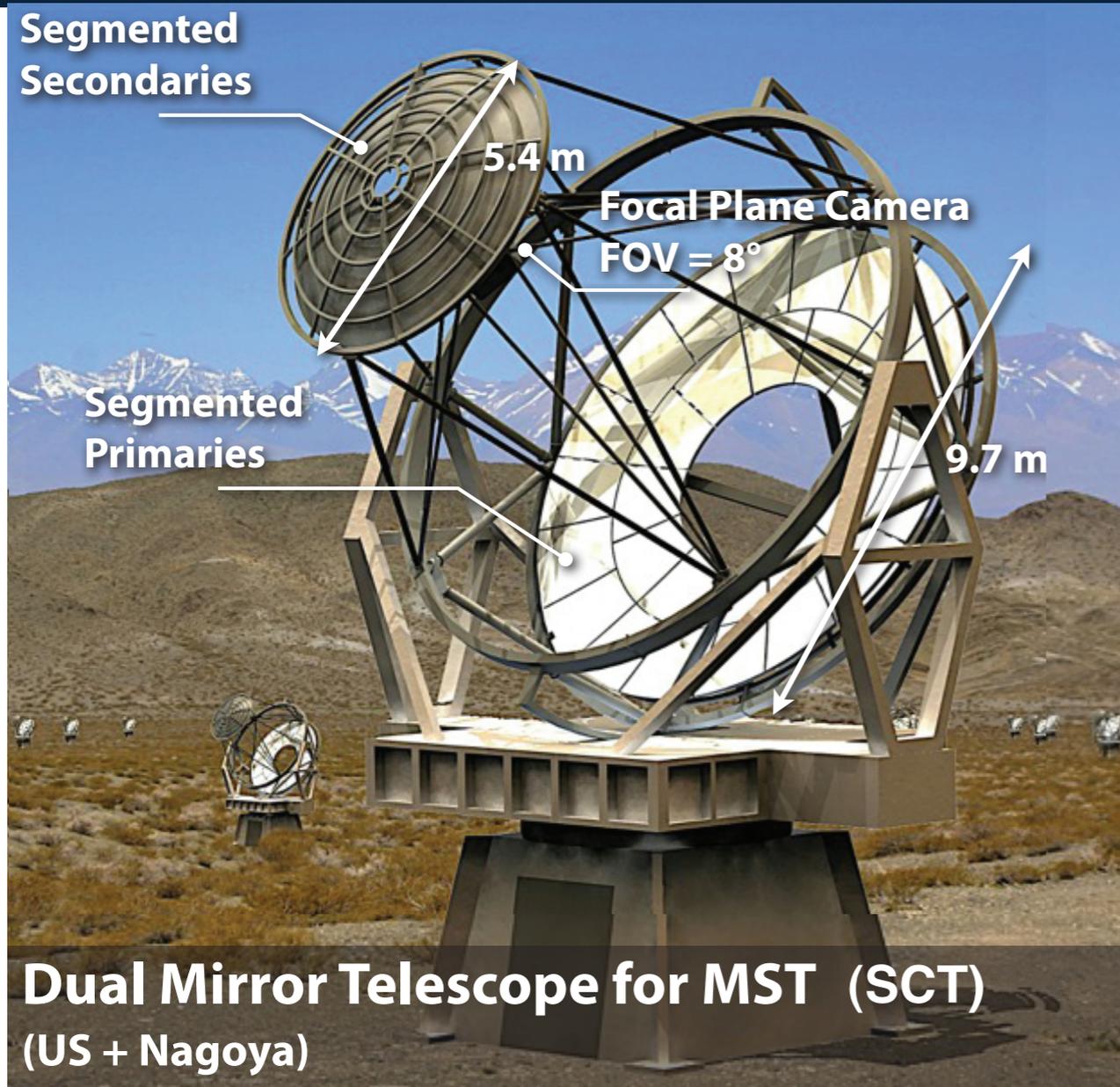
Dual Mirror Telescope



Wide FoV of 8°
Angular resolution: 4.0'

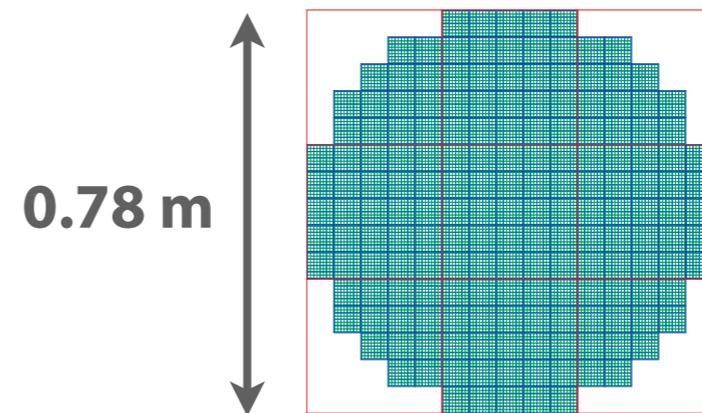
- **wide FoV, high angular resolution with good off-axis response**
- **2-mirror design reduces plate scale allowing multi channel photodetectors and reducing costs**

Dual Mirror Telescope



Wide FoV of 8°
Angular resolution: 4.0'

Focal Plane (SCT)



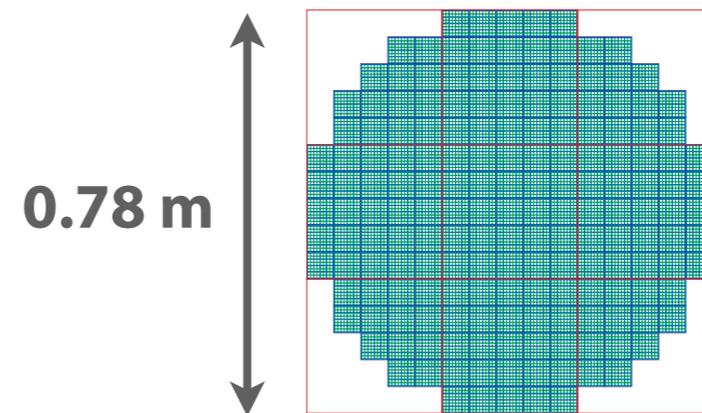
- **wide FoV, high angular resolution with good off-axis response**
- **2-mirror design reduces plate scale allowing multi channel photodetectors and reducing costs**

Dual Mirror Telescope

LST Camera
diameter
23 m



Wide FoV of 8°
Angular resolution: 4.0'

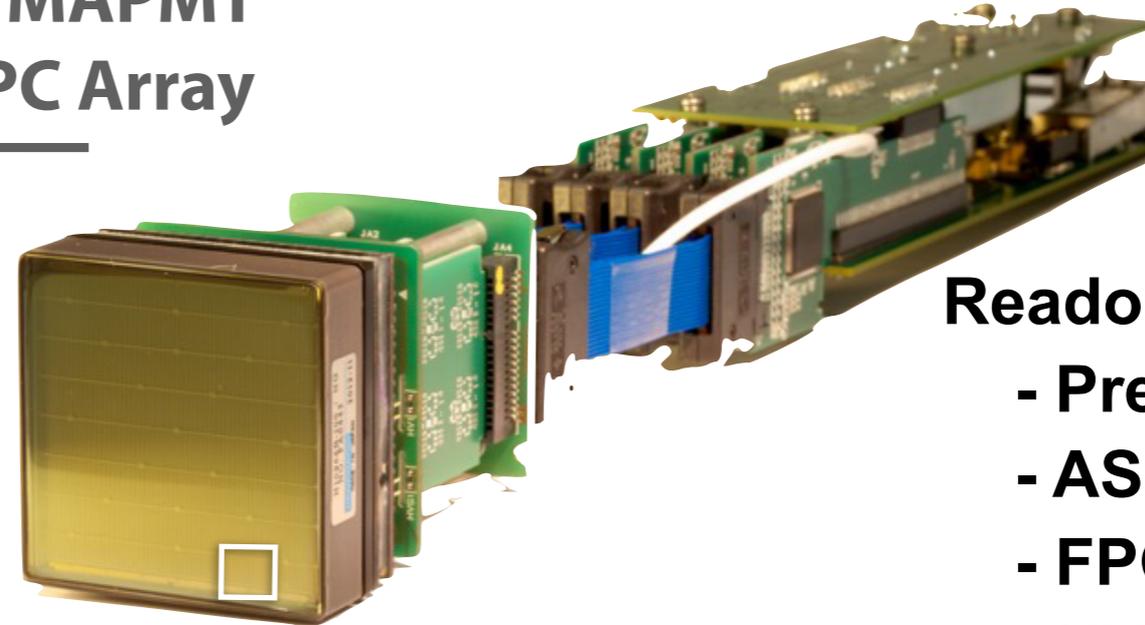
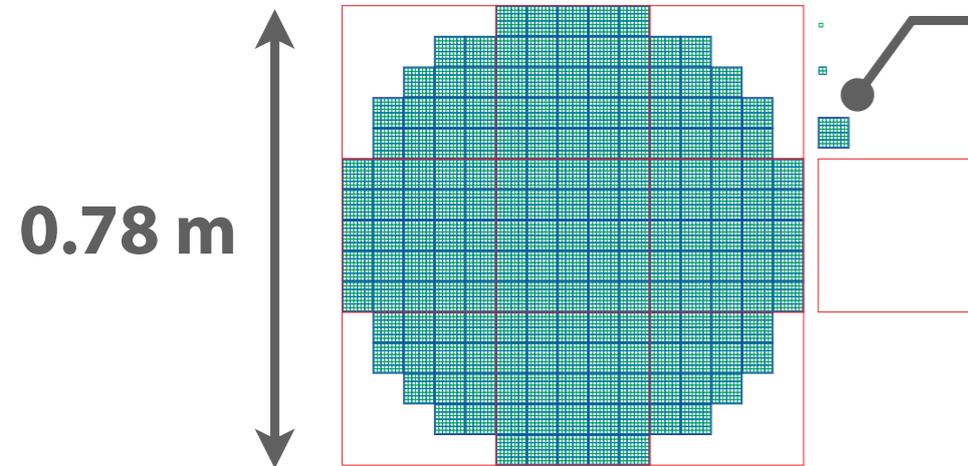


- wide FoV, high angular resolution with good off-axis response
- 2-mirror design reduces plate scale allowing multi channel photodetectors and reducing costs

Camera Module

Focal Plane (SCT)

Single MAPMT
or MPPC Array



Readout module

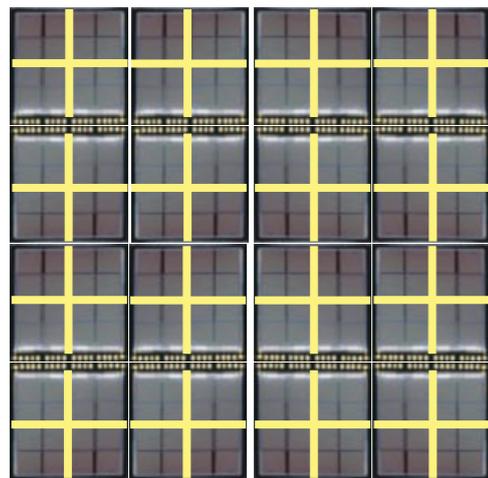
- Preamp
- ASIC ("TARGET")
- FPGA
- HV etc...

11,328 Channels

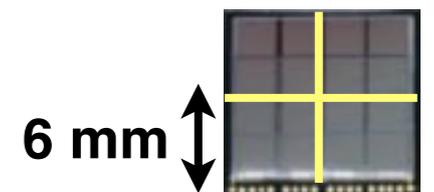
MAPMT

6.08 mm × 6.08 mm /ch

8 ch × 8 ch

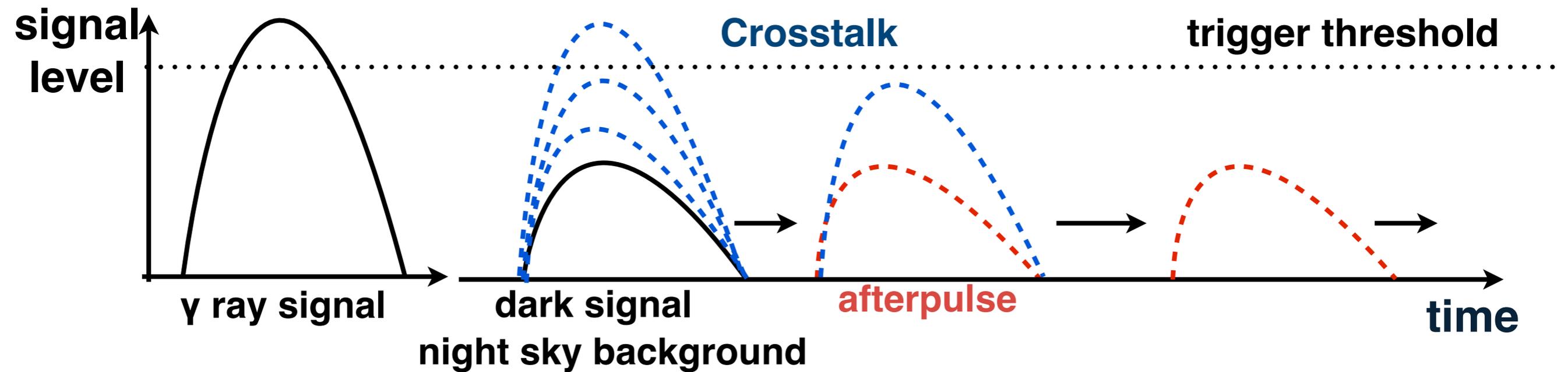


Multi Pixel Photon Counter (MPPC)
Silicone Photomultiplier device of
Hamamatsu photonics



Higher Photon Detection Efficiency

SiPM(MPPC) Characterization



Measure ratio of photon detection efficiency (PDE) compared with MAPMT

→ ~ 60% higher light yield than MAPMT

Temperature dependence of MPPC performance

• **Need to know operating temperature range of MPPCs at**

optimum performance conditions

• **Gain, PDE**

• **Dark rate, Afterpulse, Crosstalk**

→ **Accidental trigger rate**

SiPM(MPPC) Characterization

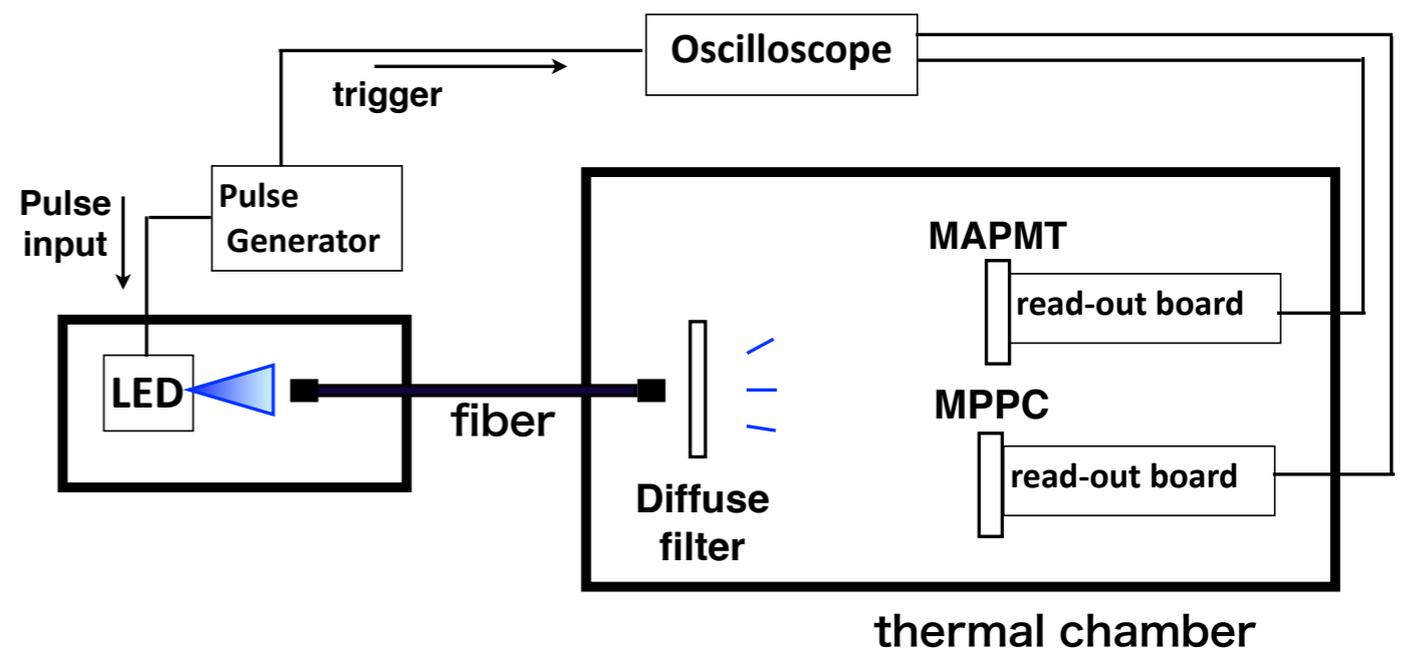
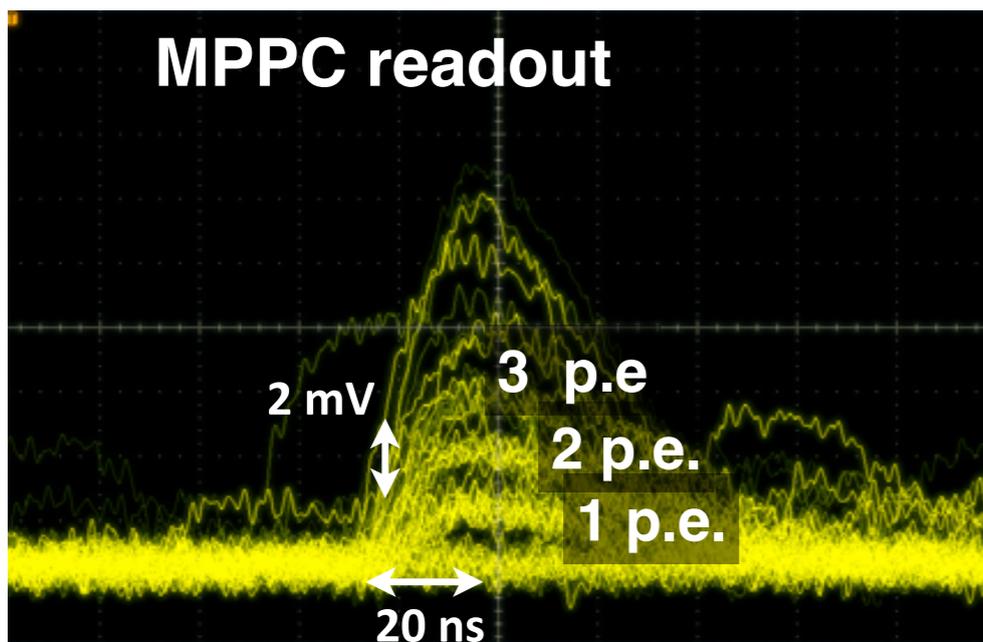
- **Setup**

- ▶ **Waveform recording**

- Proper pile up treatments
- Precise measurement of pulse shape (=gain)
- Removal of accidental dark pulse
- After pulse detection at small Δt by subtraction of primary pulse shape

- **Measurements**

- ▶ PDE, gain, dark rate, crosstalk, after pulse rate
- ▶ Wavelength dependence, temperature dependence

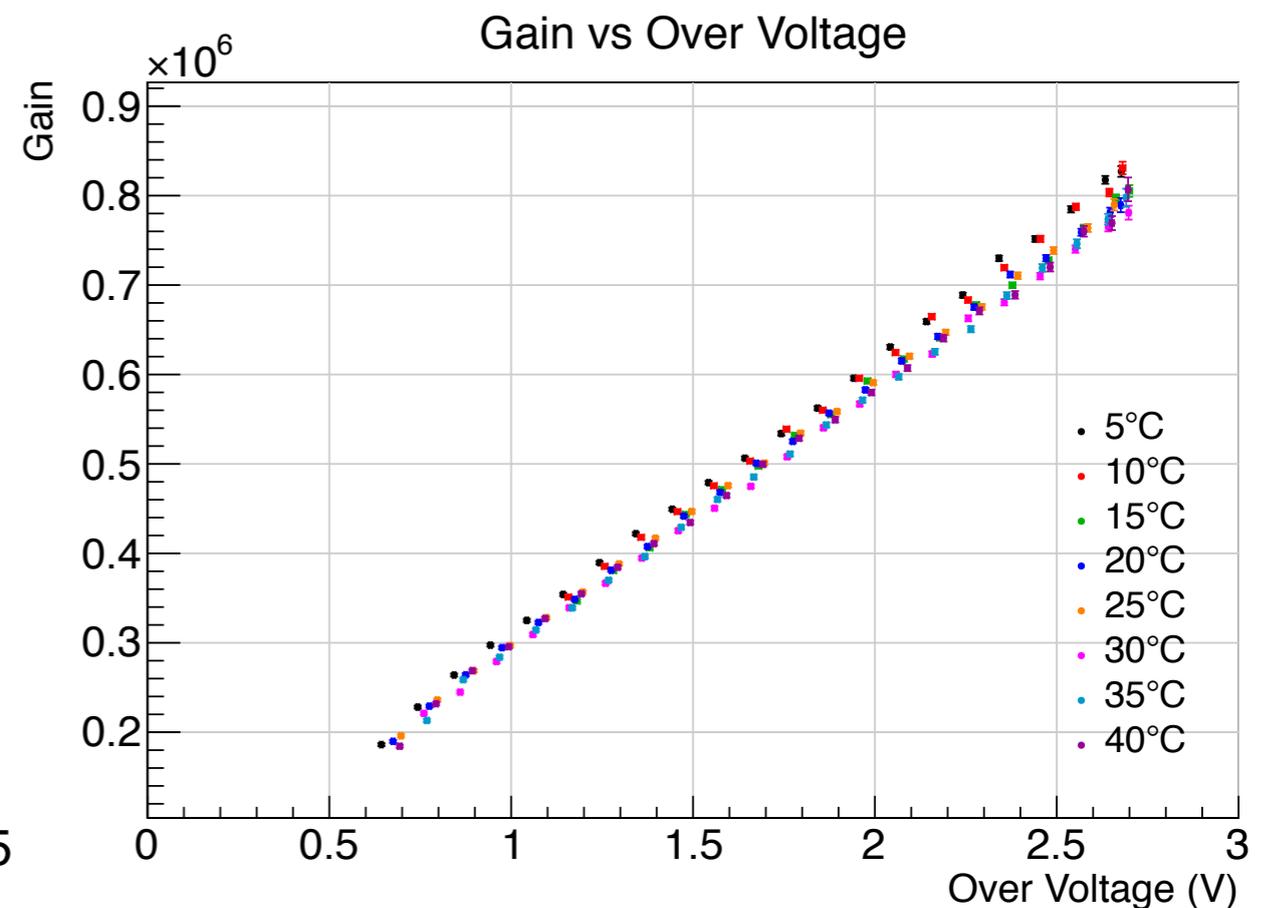
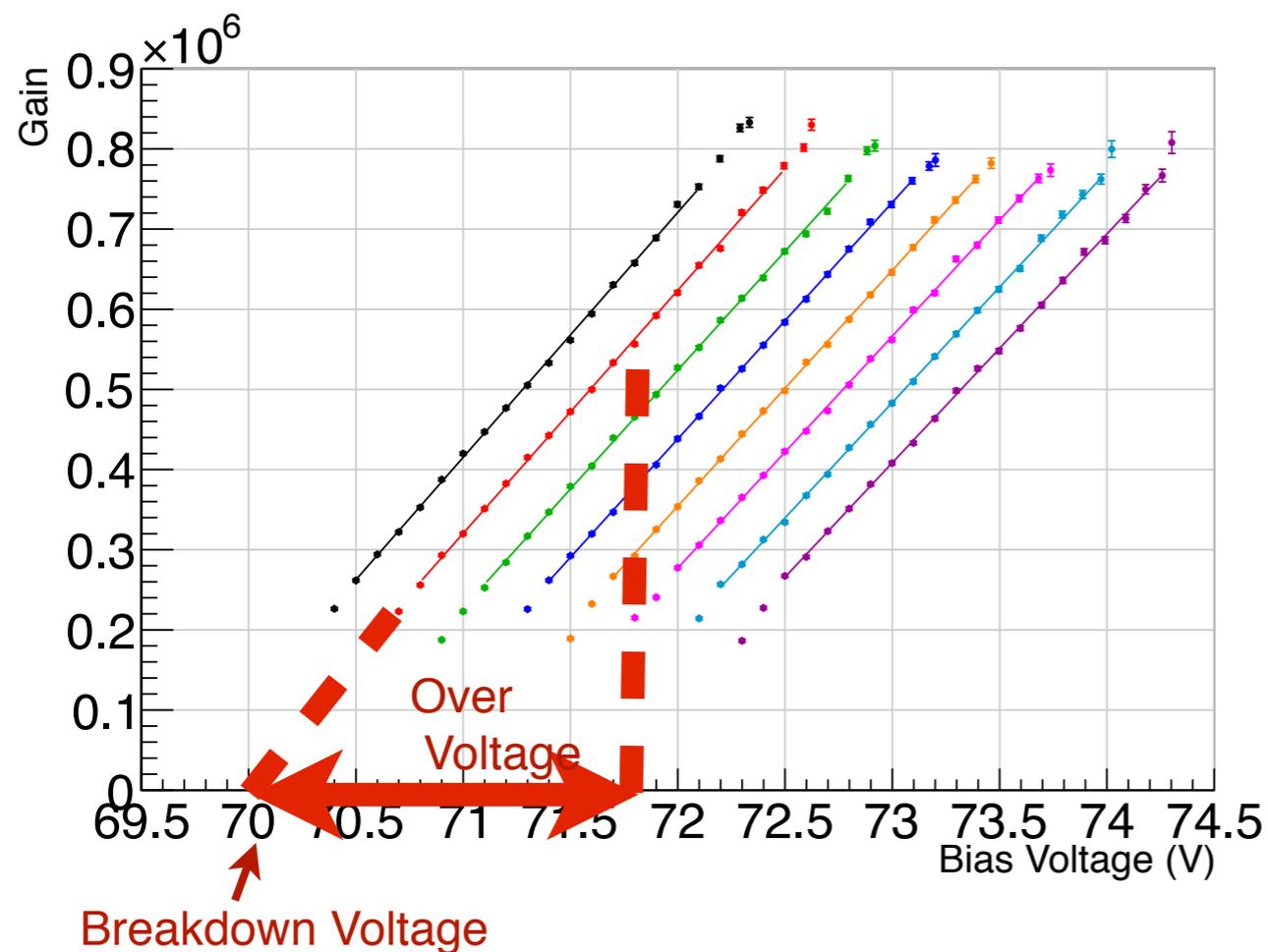


Gain

Integrate current output $V_{1 \text{ p.e.}} / R_f$

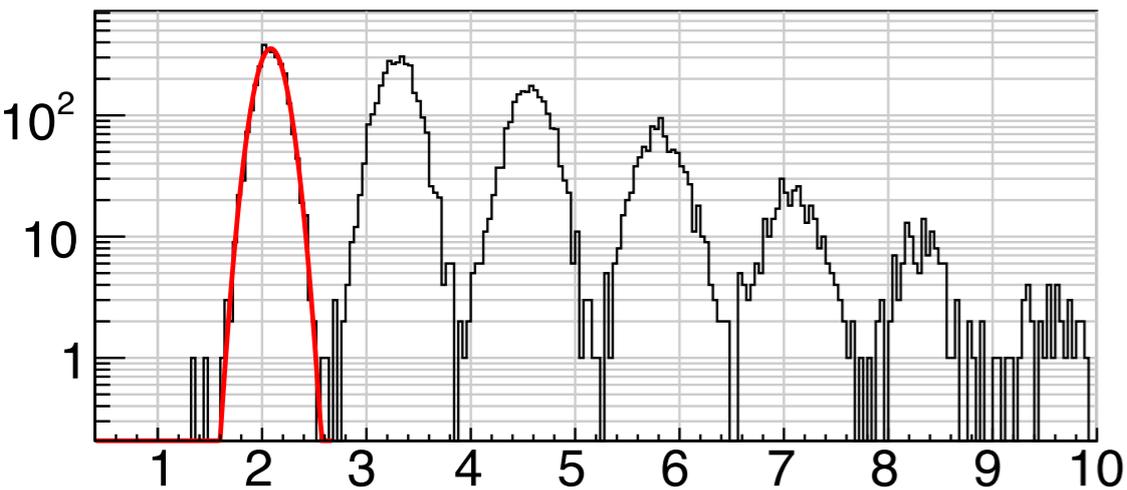
$V_{1 \text{ p.e.}}$: output voltage / p.e. (from the histogram of pulse height)

R_f : feedback resistor

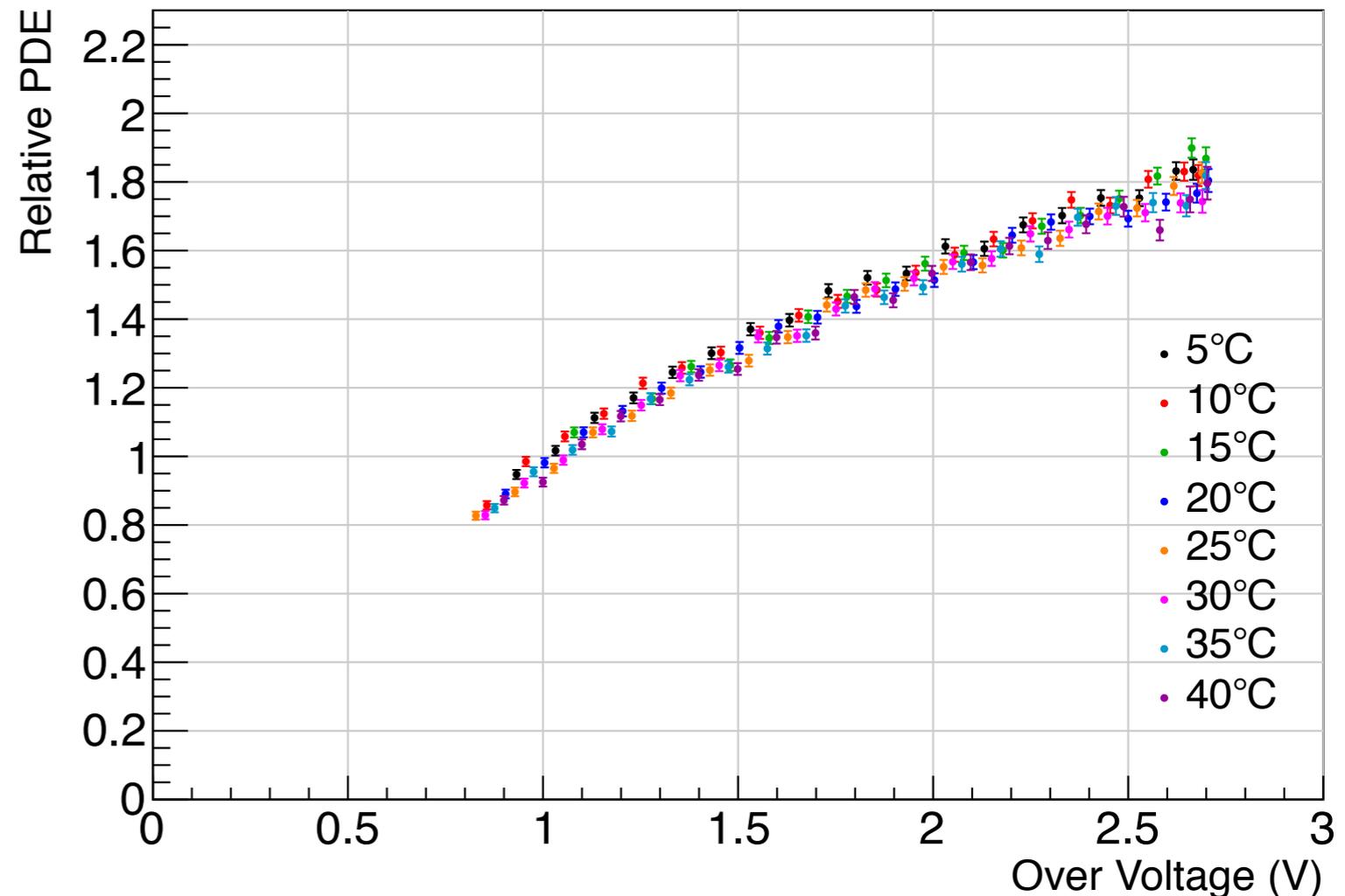


Photon Detection Efficiency

Count the number of detected photons from pulse height distribution



Relative PDE vs Over Voltage



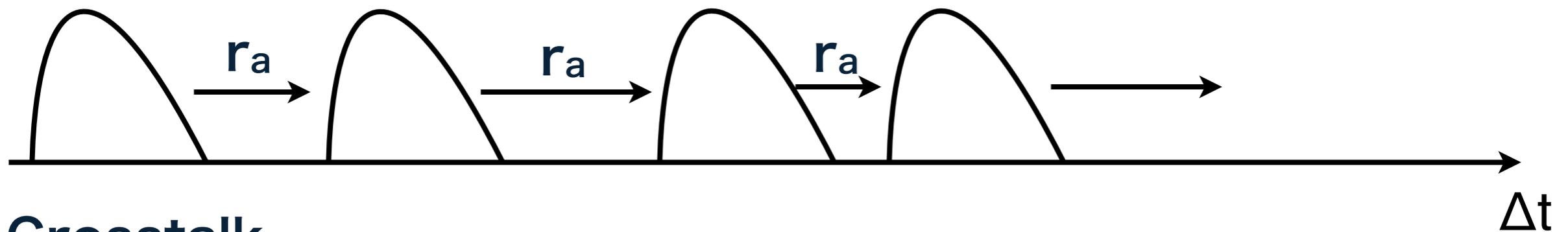
PDE have stable performance under control of bias voltage
accidental trigger rate is more important
→ dark count, crosstalk rate, afterpulse rate measurement

Pixel Trigger Rate

- Dark count + Night Sky Background

- Afterpulse rate r_a

▶ factor $\frac{1}{1 - r_a}$



- Crosstalk

→ 4 p.e. threshold

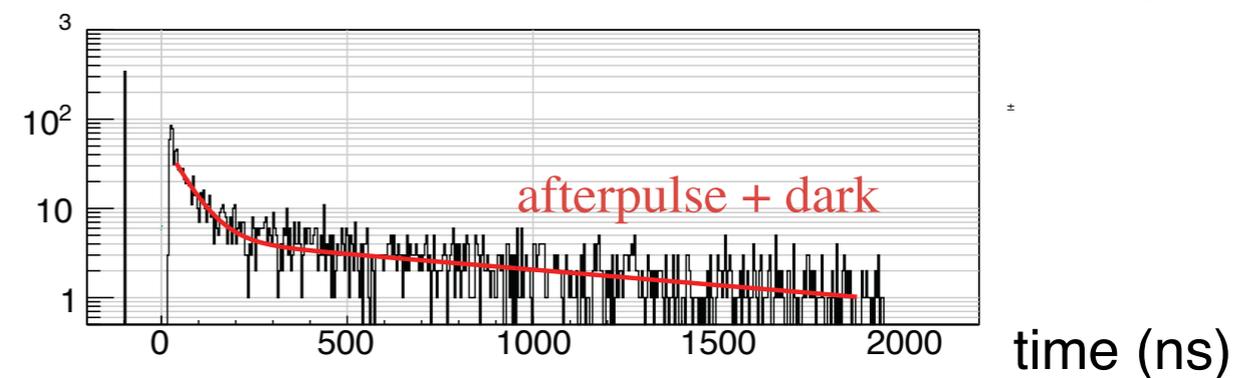
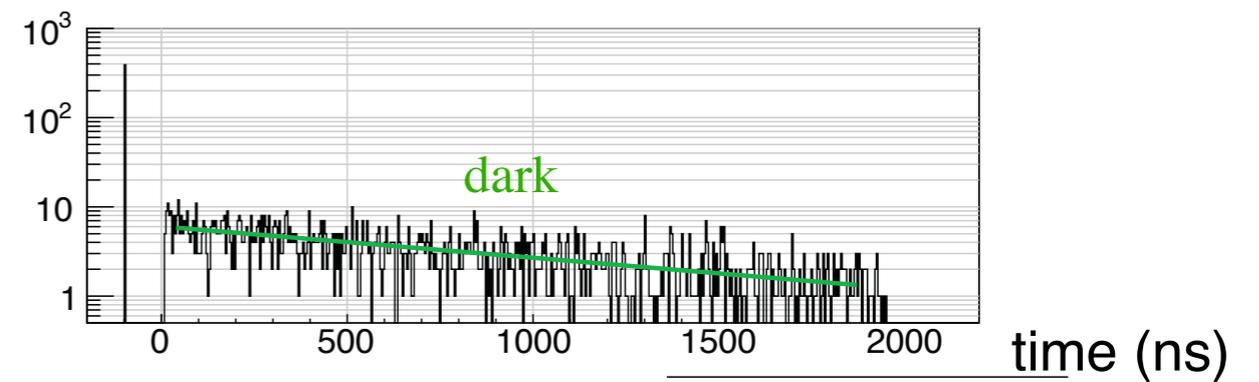
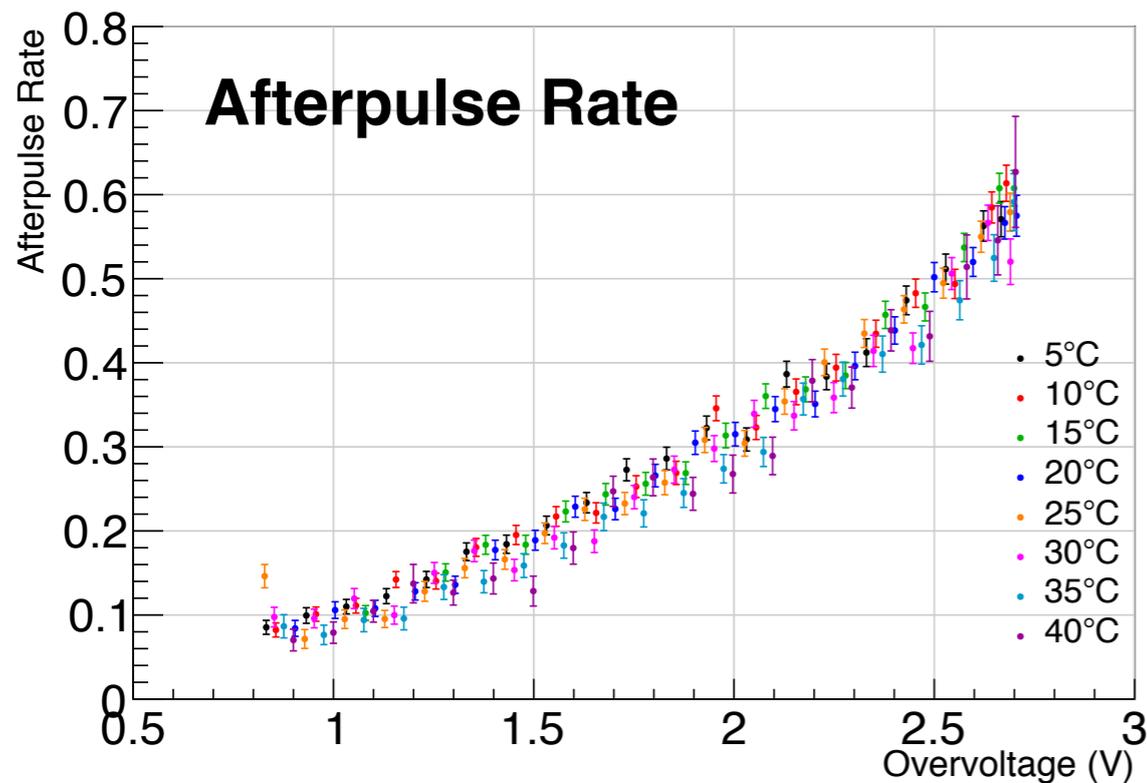
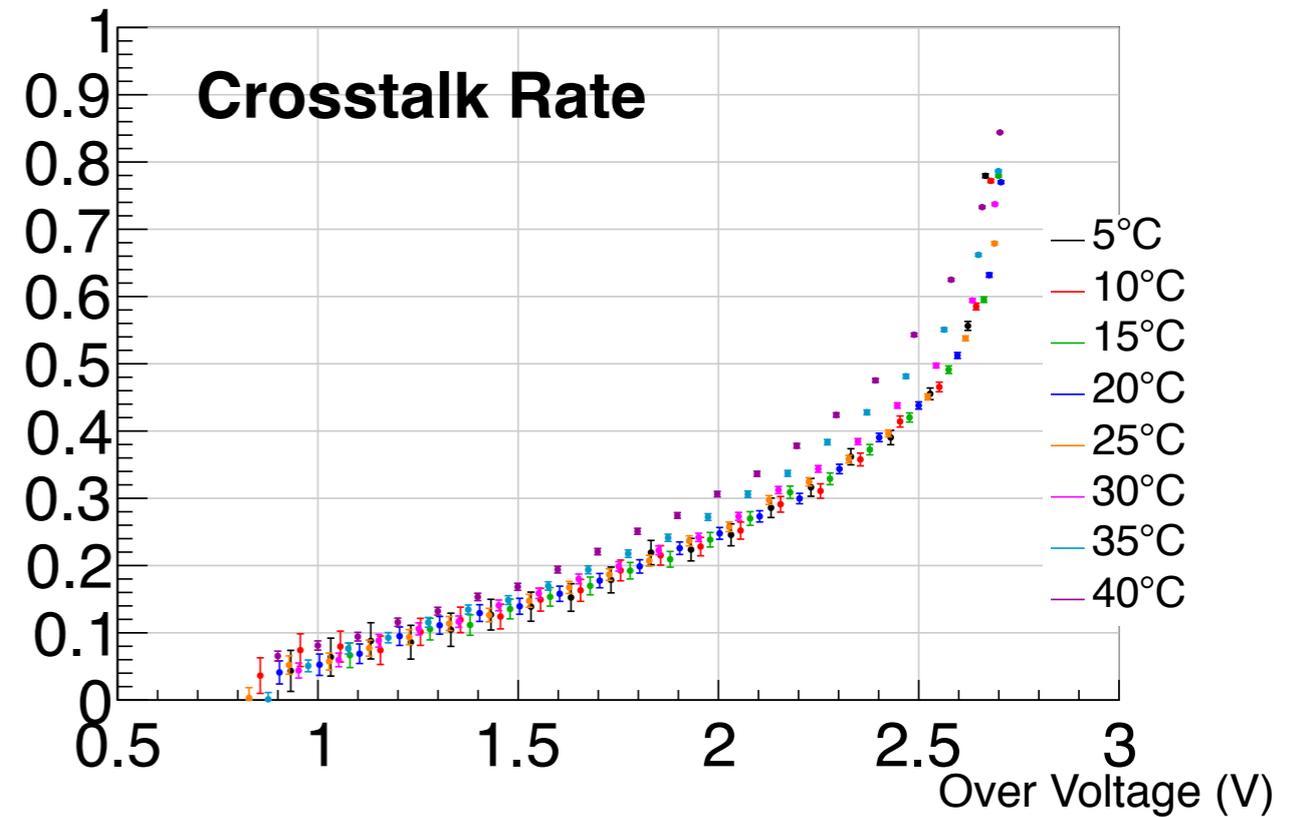
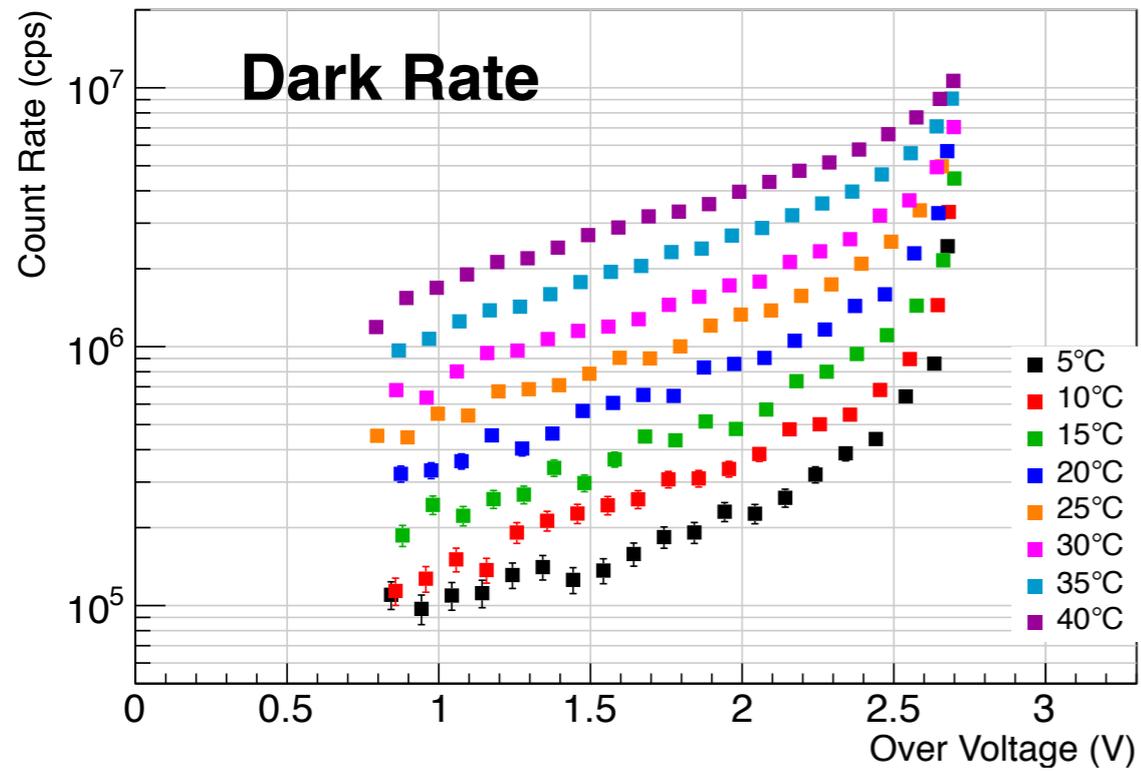
$$(f_{\text{NSB}} \cdot \text{PDE} + \underline{f_{\text{dark}}}) \times \underline{\frac{1}{1 - r_a}} \times \{ \underline{1 - (P(0) + P(1) \times P(0) + P(2) \times P(0)^2 + P(1) \times P(1) \times P(0))} \}$$

f_{NSB} : Night Sky Background rate

f_{dark} : Darkcount Rate

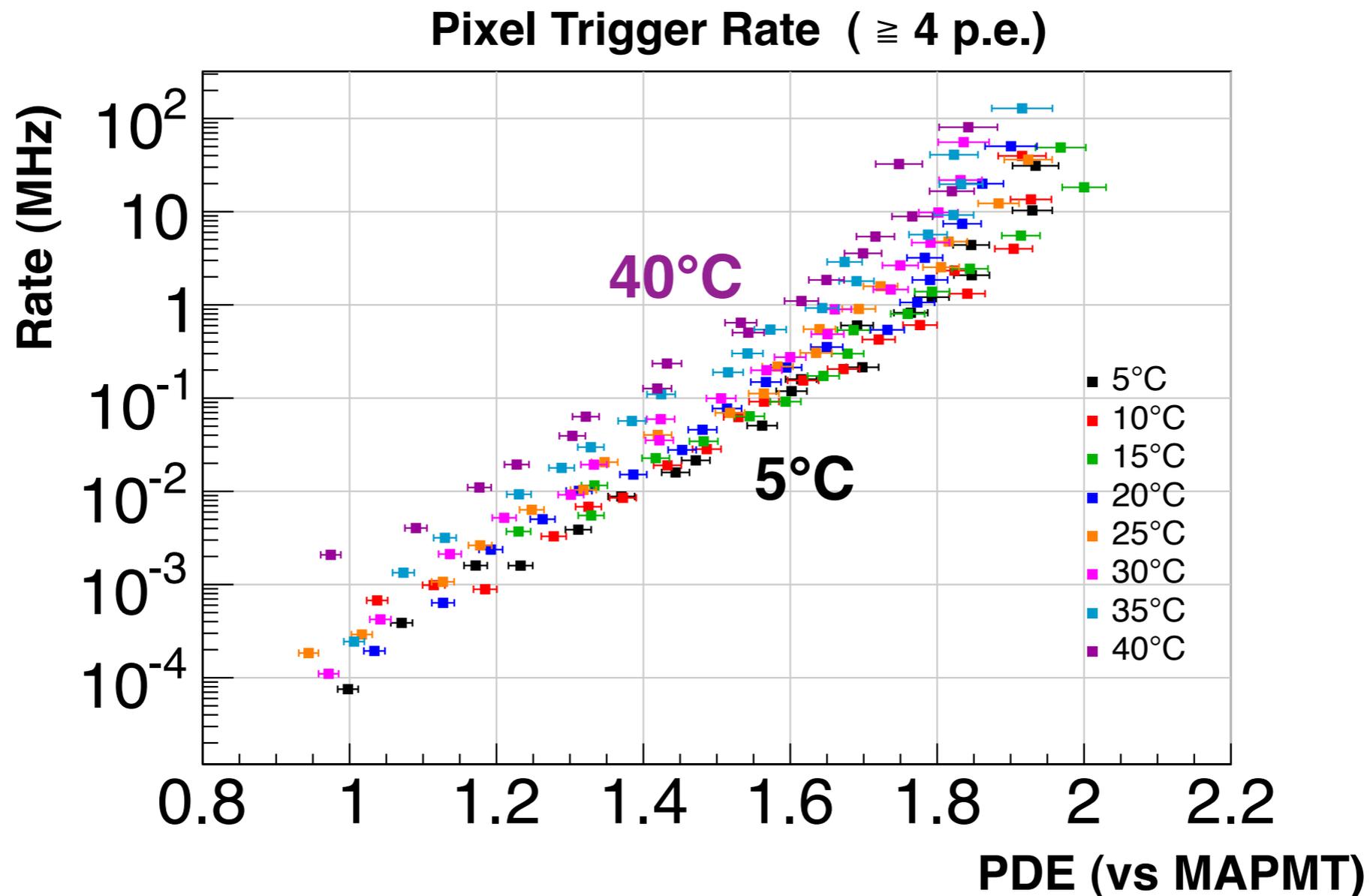
Dark rate, Afterpulse, Crosstalk

Dark Rate at threshold 0.5p.e. vs Bias Voltage



Pixel Trigger Rate

- 6mm × 6mm pixel
- NSB = 5 MHz

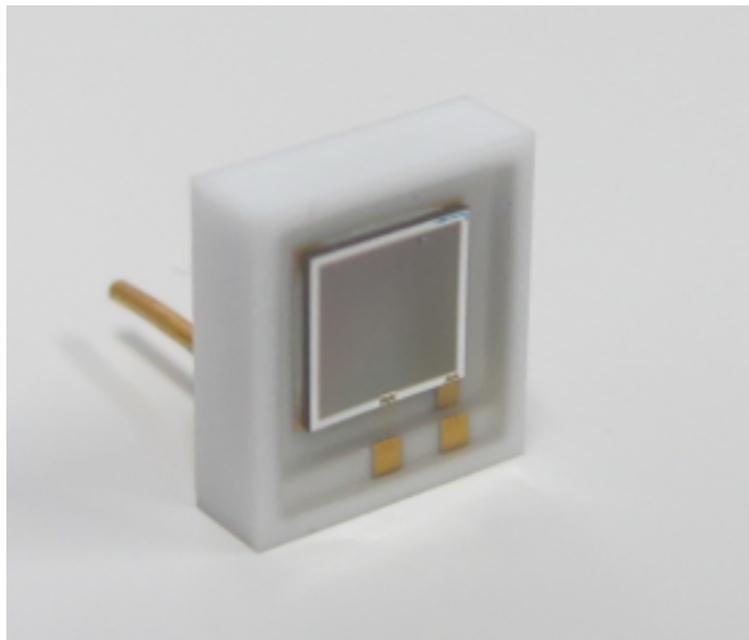


→ ~ 10 MHz at high PDE

increase 10 times from 5°C to 40°C

Recent Work

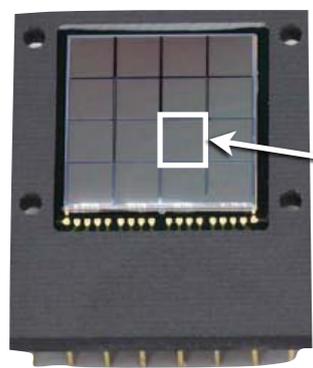
- Evaluation the accidental trigger rate
 - ▶ Simulation with trigger logic of telescope
- MPPC with trenches
 - ▶ implemented to suppress crosstalk
- evaluation of performance of “camera module”
 - ▶ MPPC array + readout



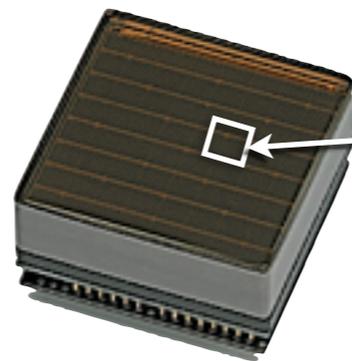
Back up

Photon Detection Efficiency Comparison

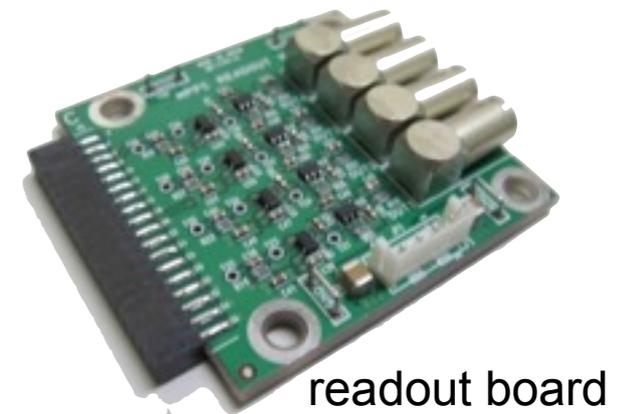
Measure ratio of MAPMT efficiency compared with MPPC efficiency



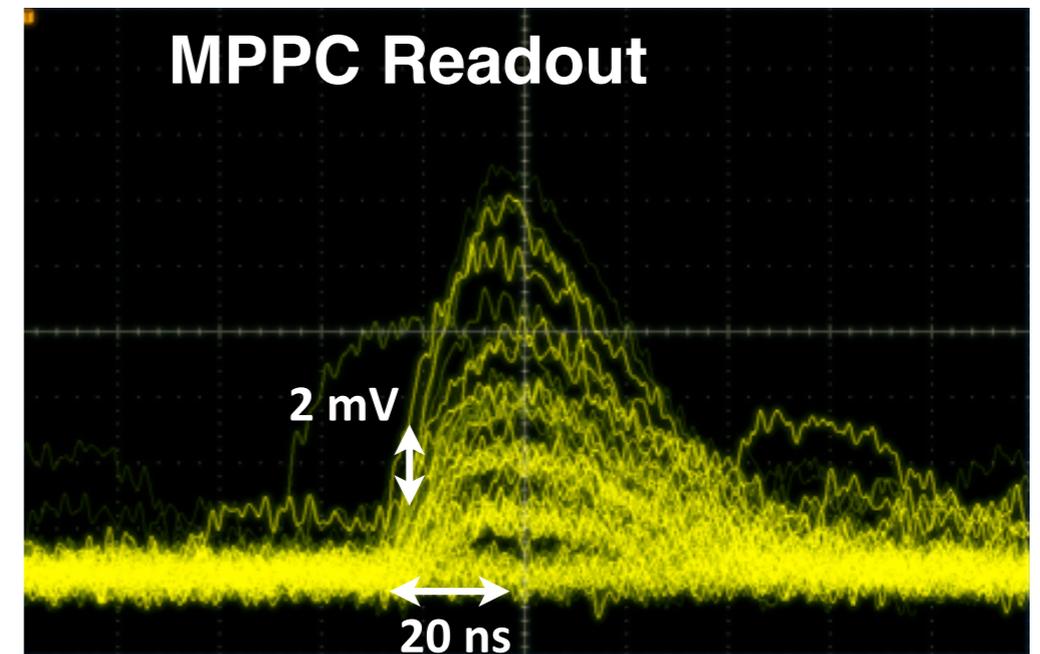
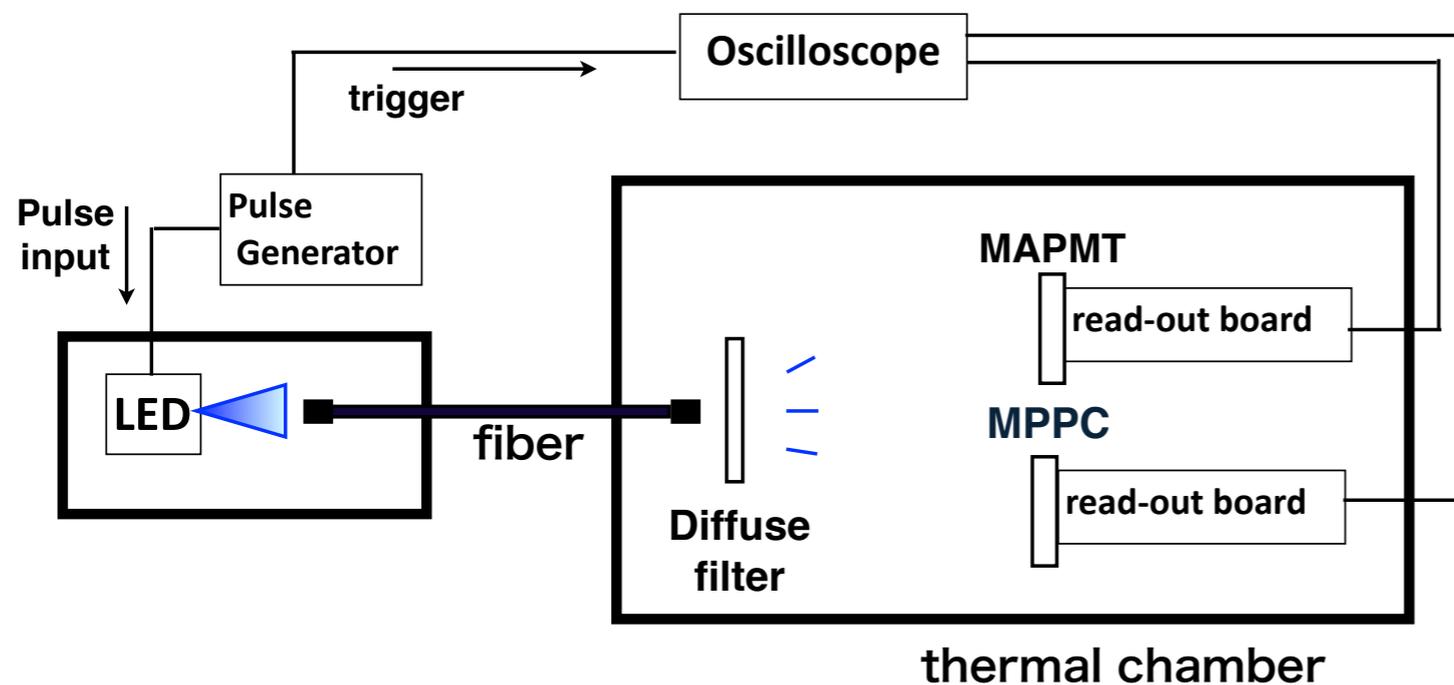
MPPC
S11827-3344MG
3 mm × 3 mm /ch
4 ch × 4 ch
50 μm GAPDs



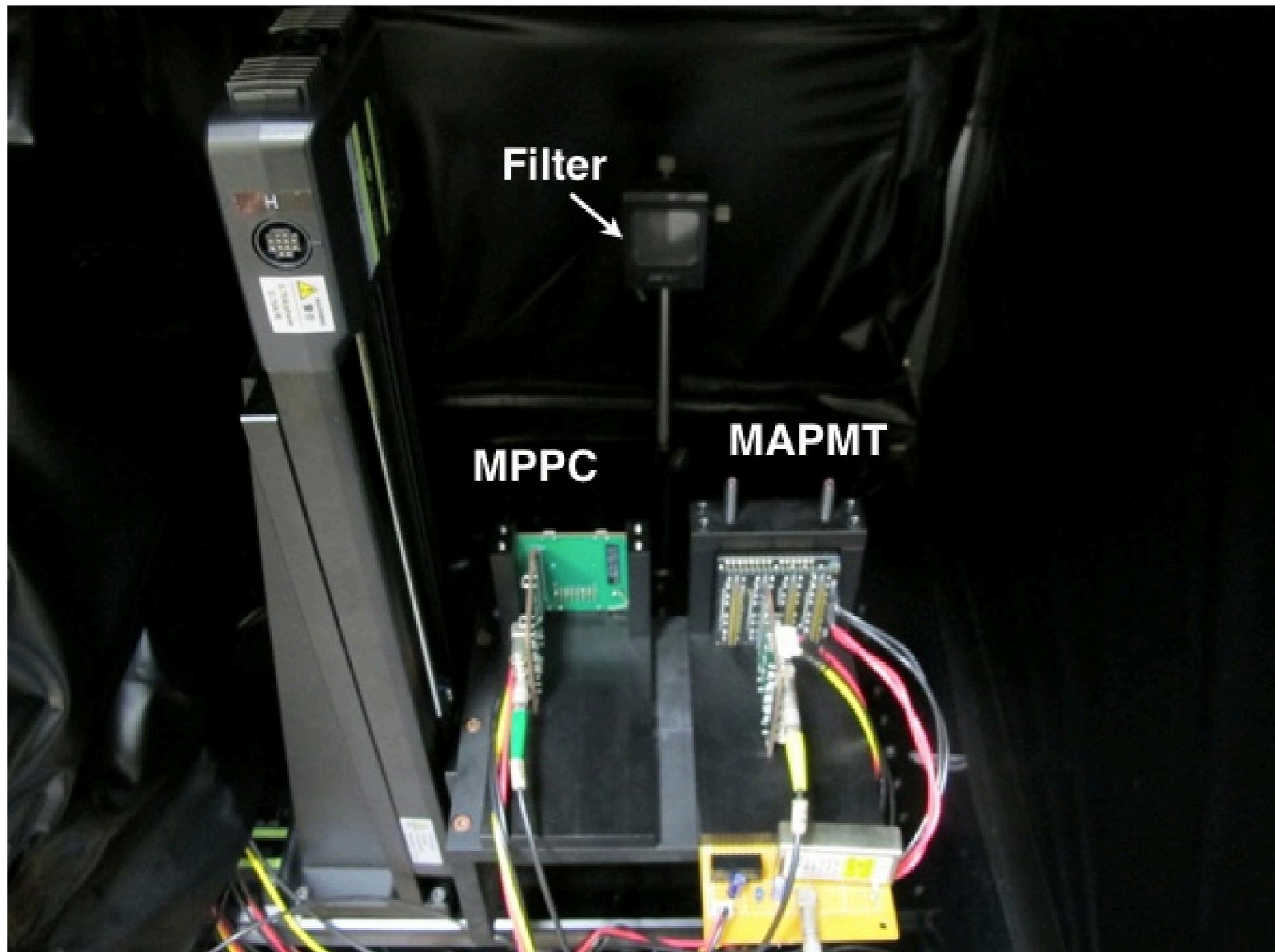
MAPMT
H8500-D
6.08 mm × 6.08 mm /ch
8 ch × 8 ch



readout board



Measurement System



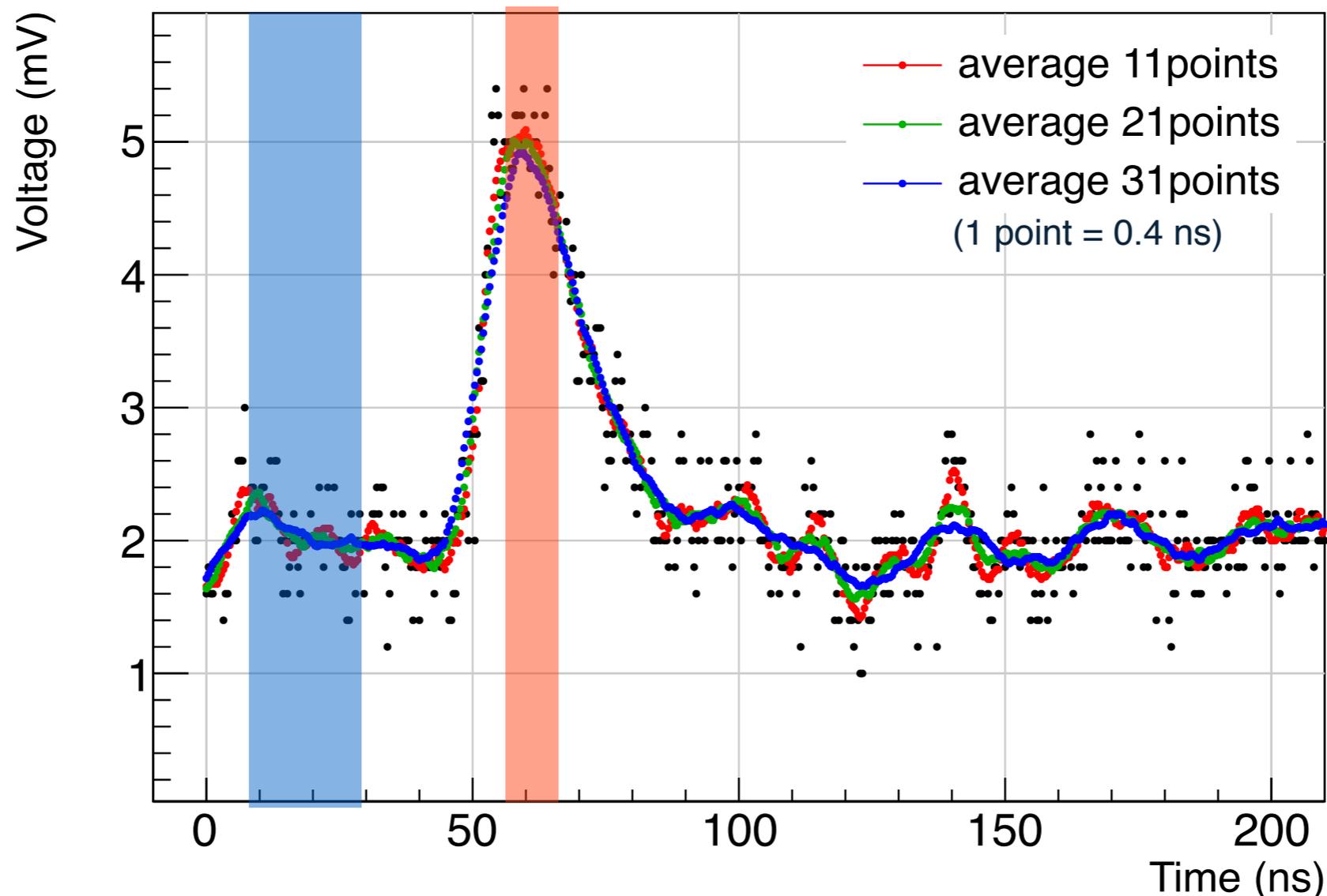
Analysis Method

Pulseheight at the time of LED emission

before average waveform around 8-ns average

Remove events if the baseline (shown in blue) is outside of nominal distribution

Remove off-timing events



Fit Method

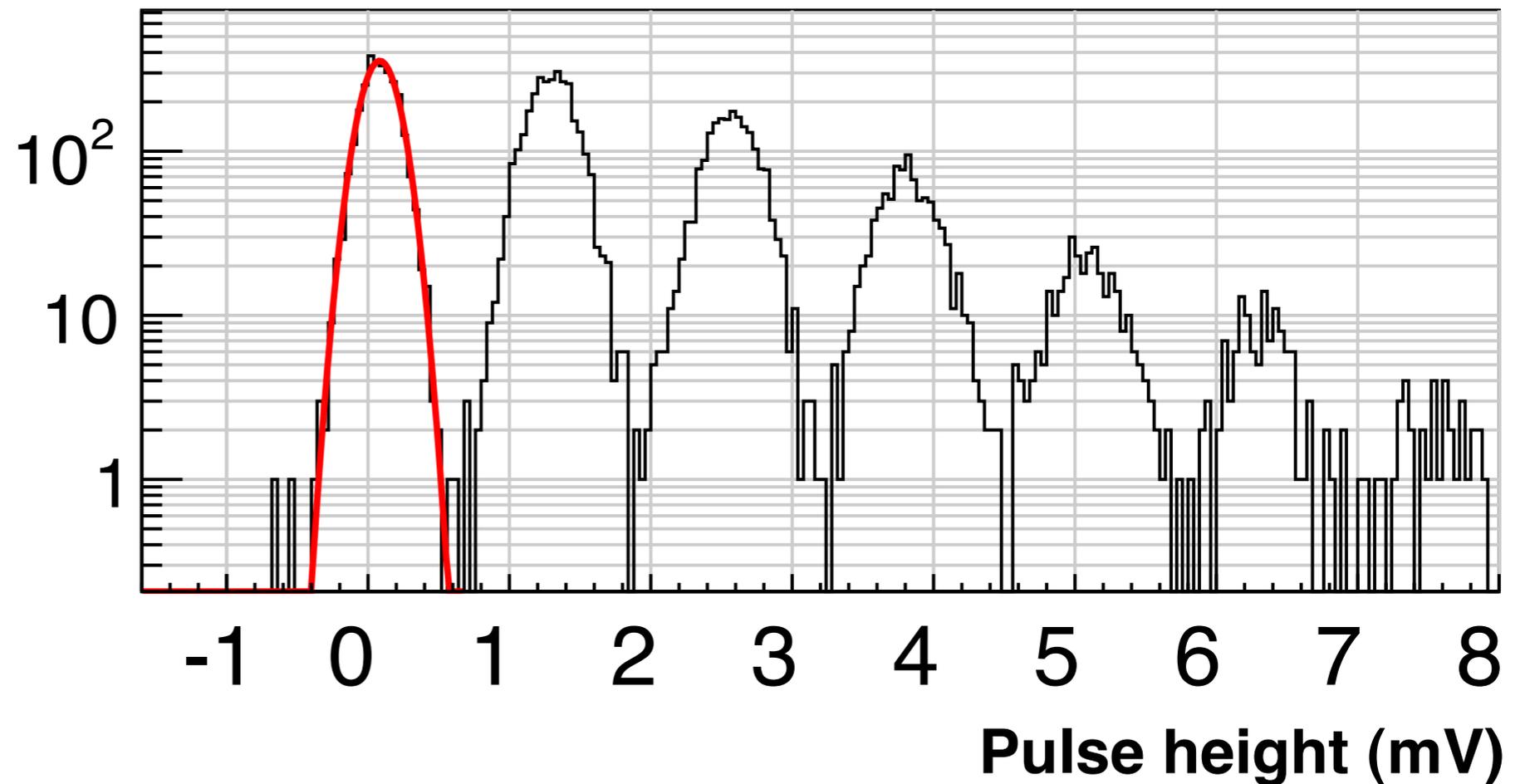
Fit to 0 p.e. distribution: $P(0)$

- Avoid effect of crosstalk and after-pulse

$$P(k) = e^{-\lambda} \frac{\lambda^k}{k!}$$

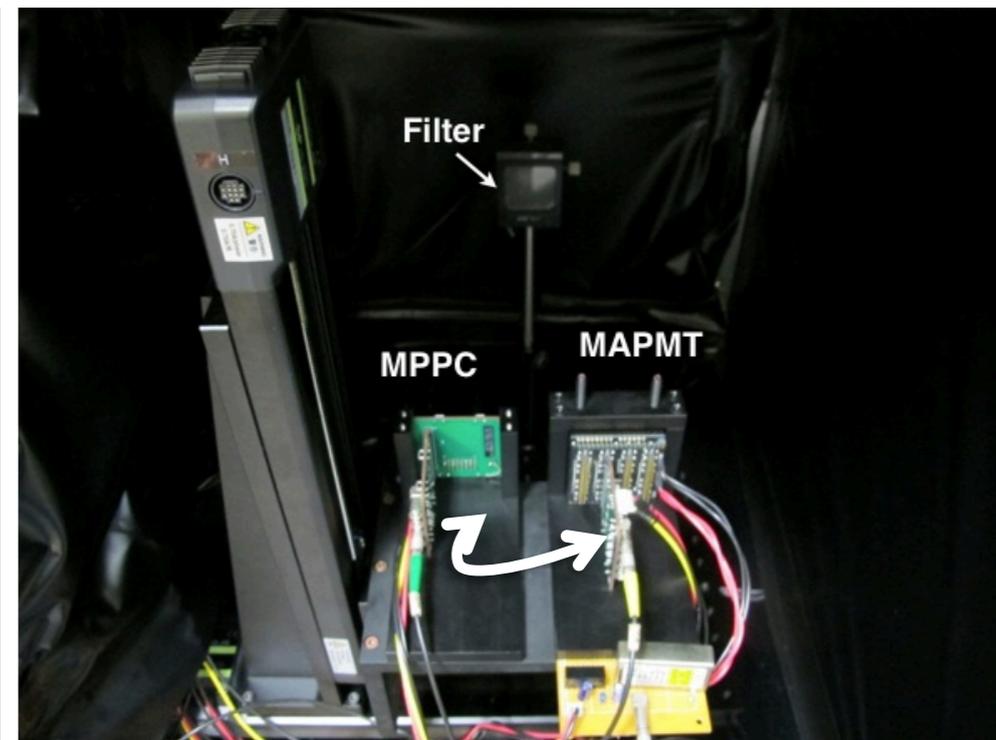
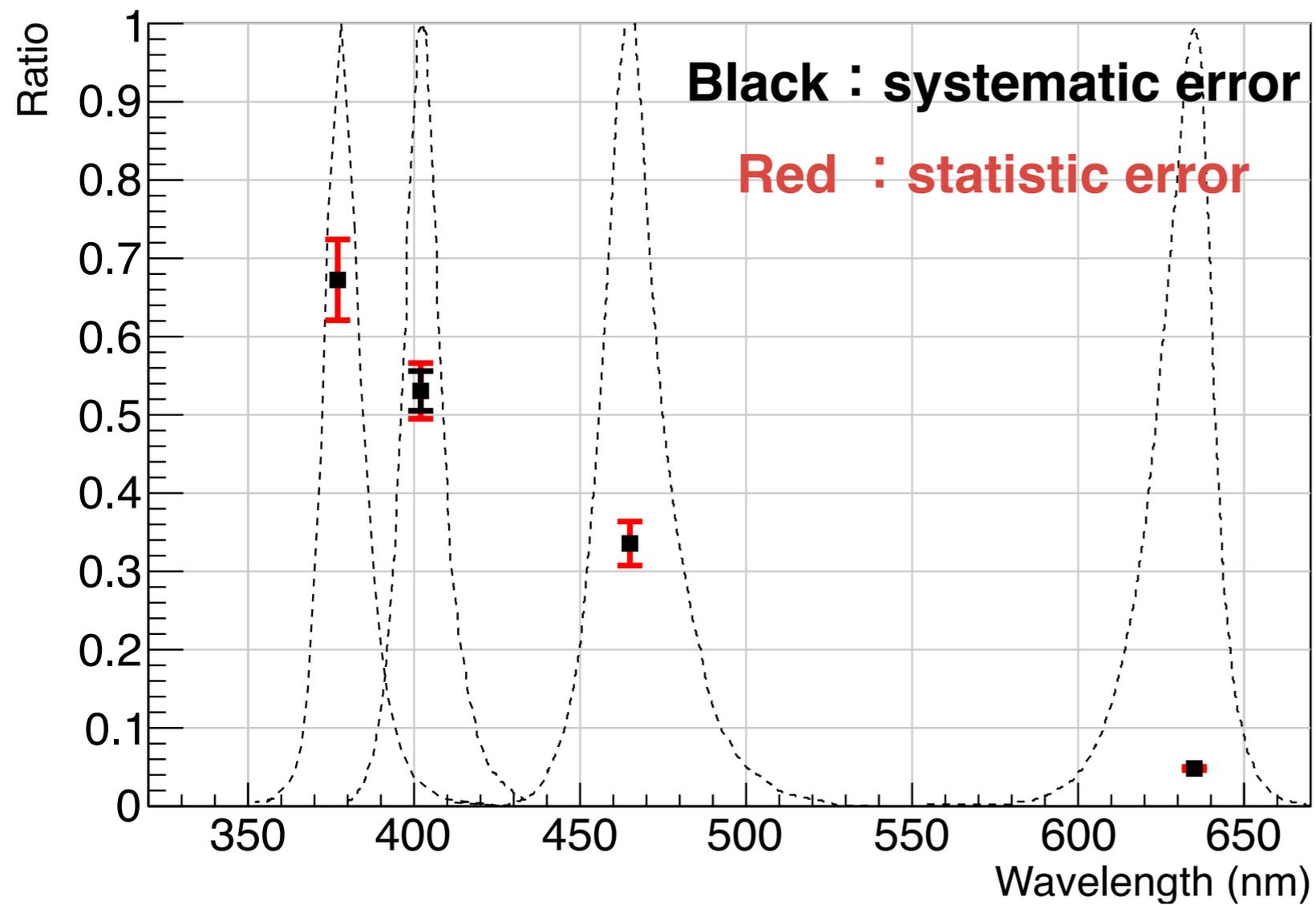
$$P(0) = e^{-\lambda}$$

$$\lambda = \ln(P(0))$$



PDE ratio measurements

$$\text{PDE Ratio} = \frac{\lambda(\text{MAPMT})}{\lambda(\text{MPPC})} = \frac{\varepsilon(\text{MAPMT})}{\varepsilon(\text{MPPC})}$$



Calculation of Cherenkov Light Yield

Integrate Cherenkov light spectrum weighted by photon detection efficiency up to 550 nm

- ▶ **Avoid Oxygen fluorescent line**
- ▶ **MPPC PDE from catalog**
- ▶ **MAPMT PDE from MPPC PDE and PDE ratio**

$$\text{LY(MPPC)/LY(MAPMT)} = 2.04$$

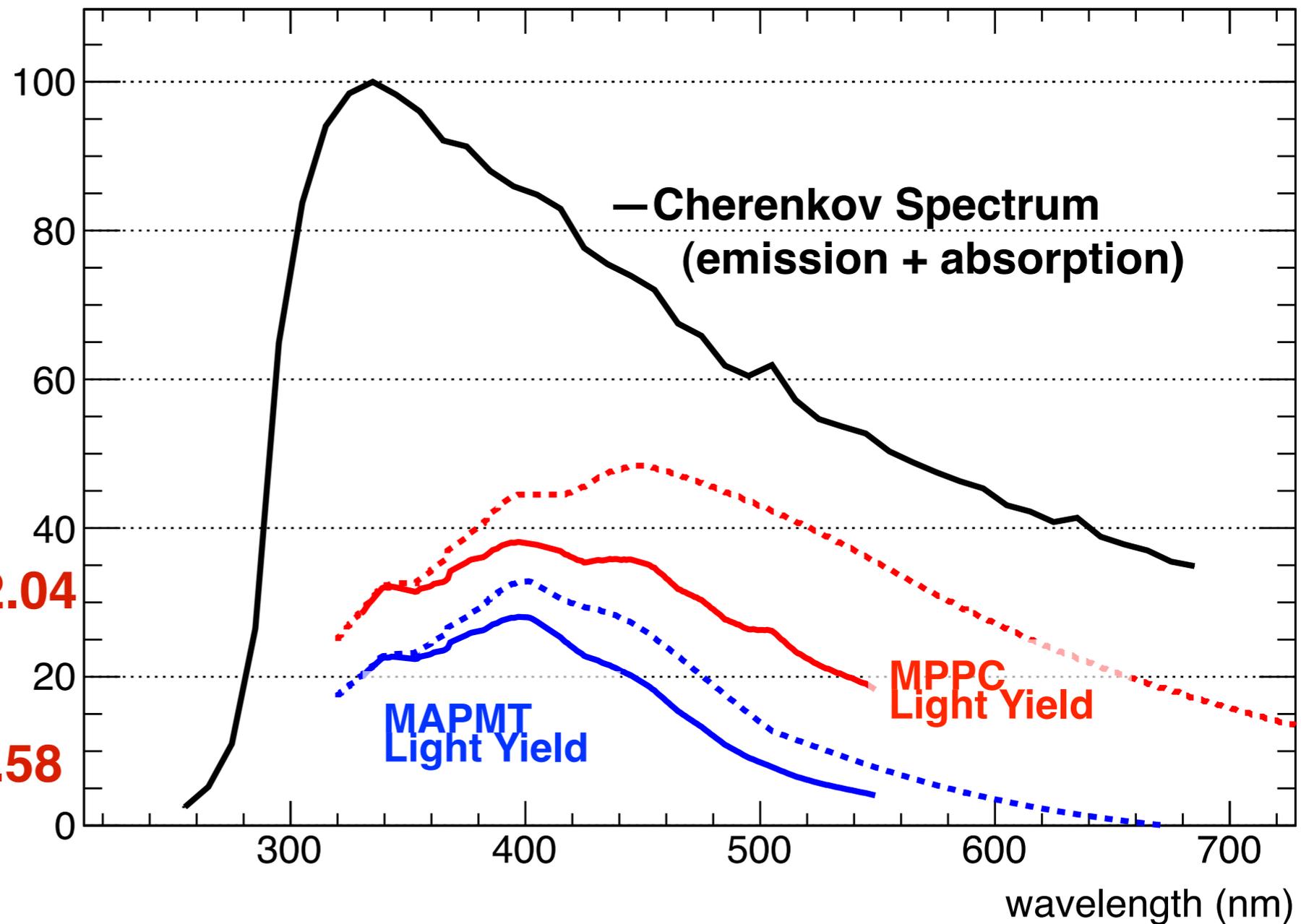
Correcting light loss at boundary of each unit

$$\text{LY(MPPC)/LY(MAPMT)} = 1.58$$

$$\varepsilon(\text{MAPMT}) = 89\%$$

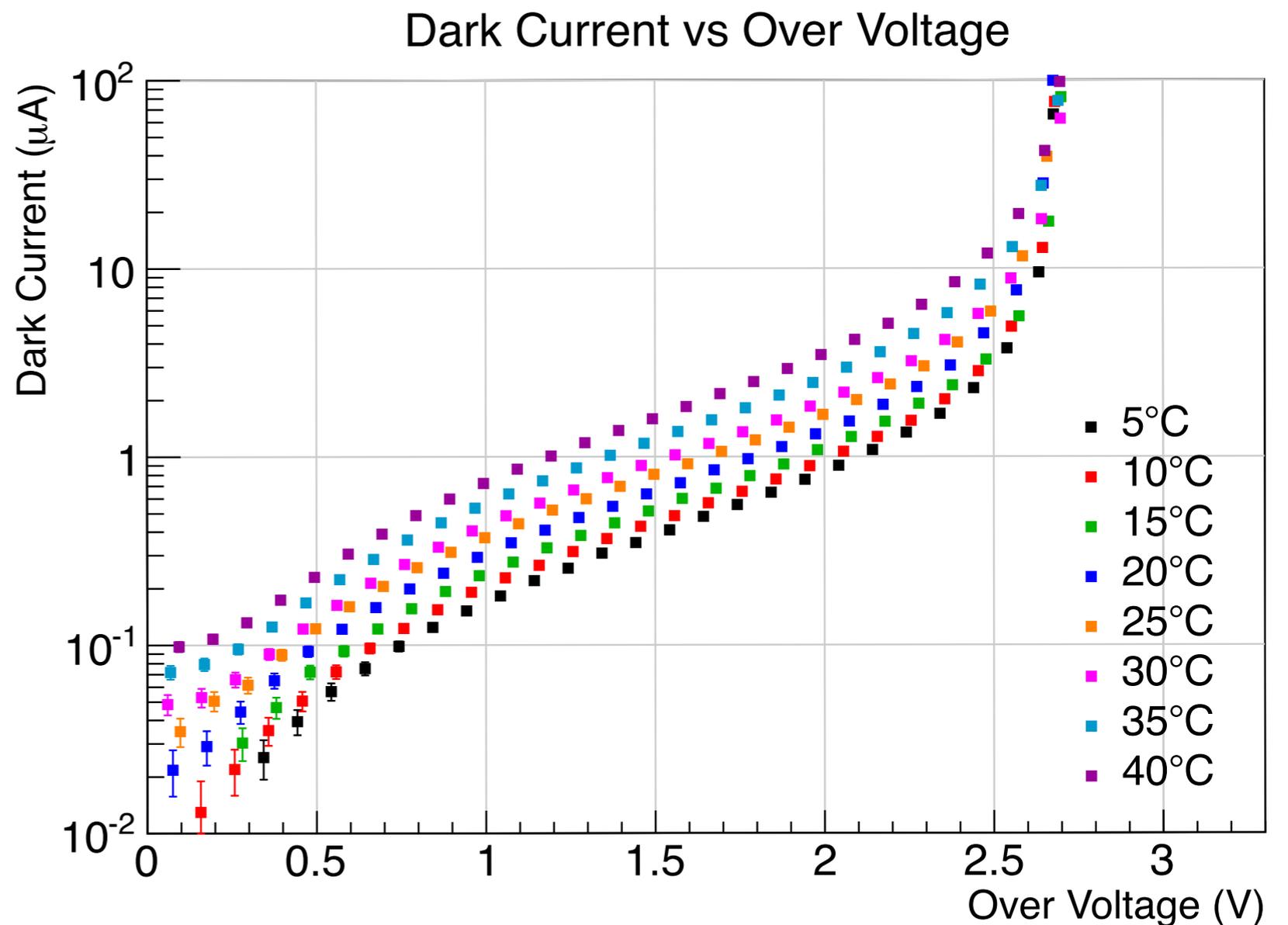
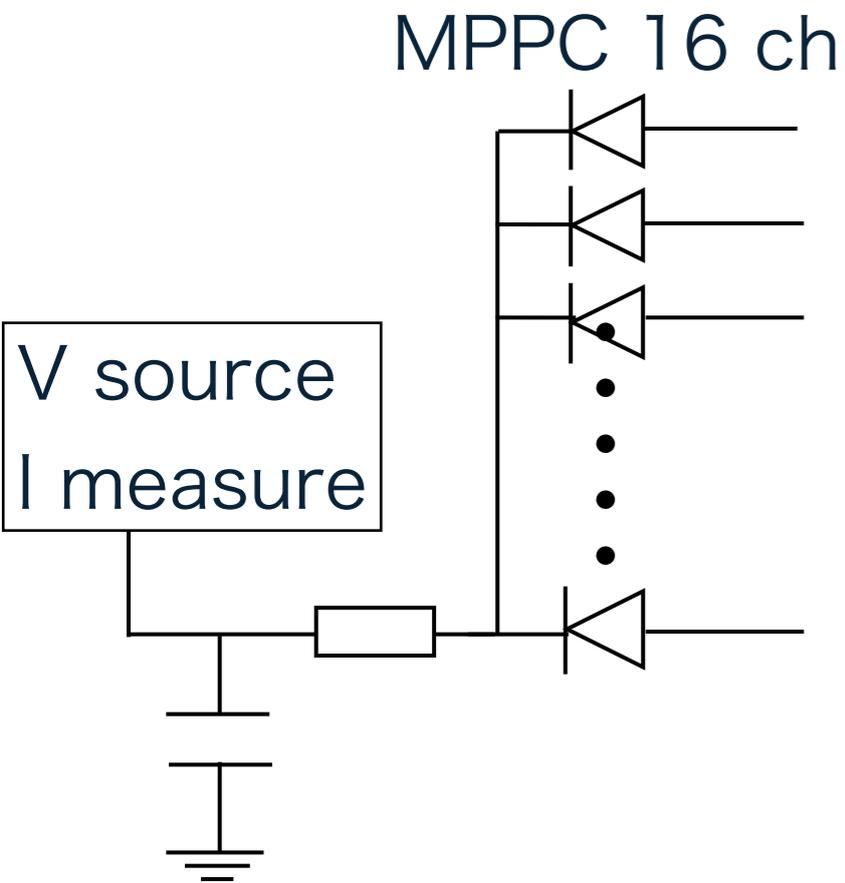
$$\varepsilon(\text{MPPC}) = 69\%$$

(0.5 mm gap between units)



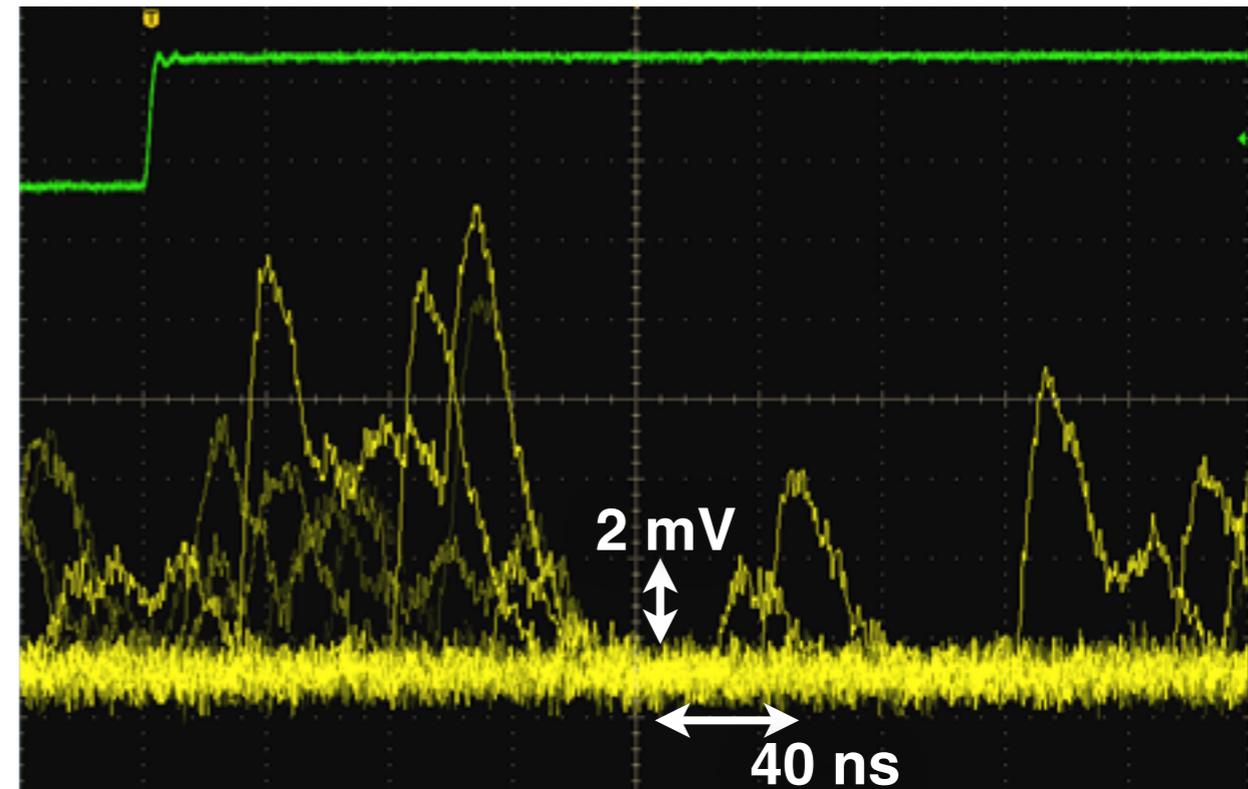
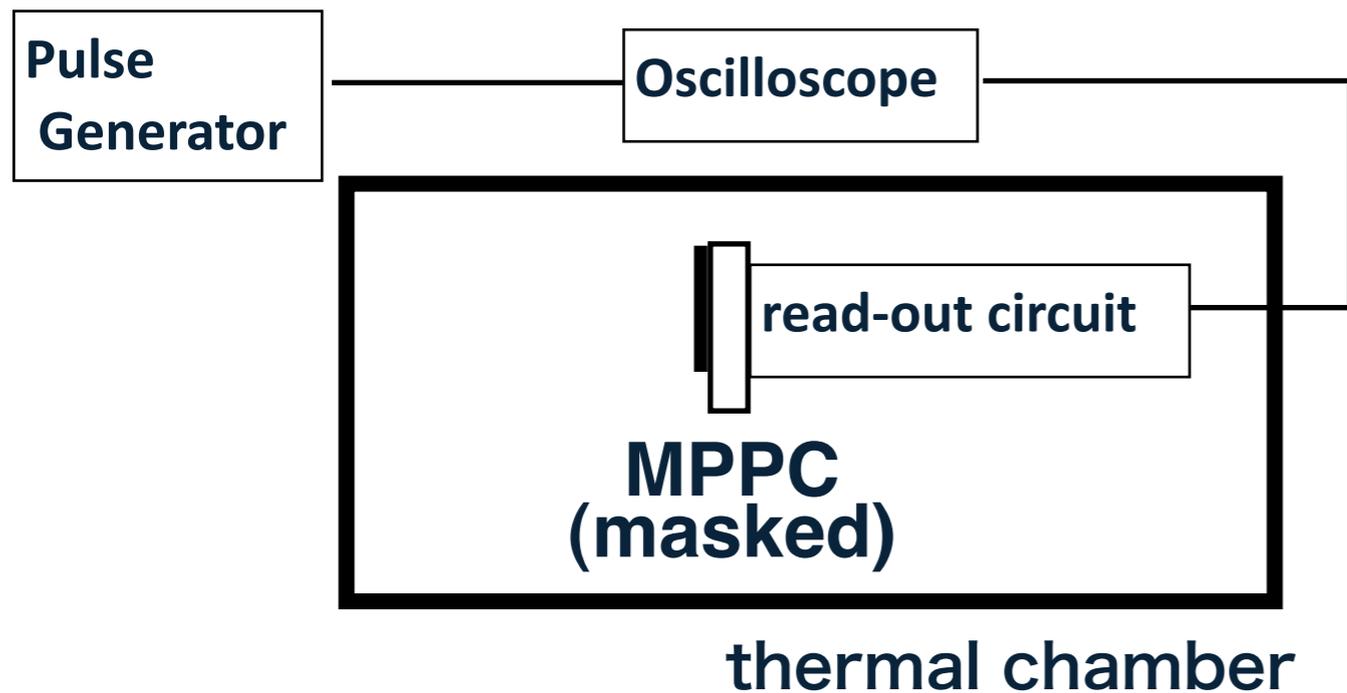
Dark Current vs Over Voltage

Current begins to get higher sharply at the voltage over 2 – 3 V of the break-down voltage



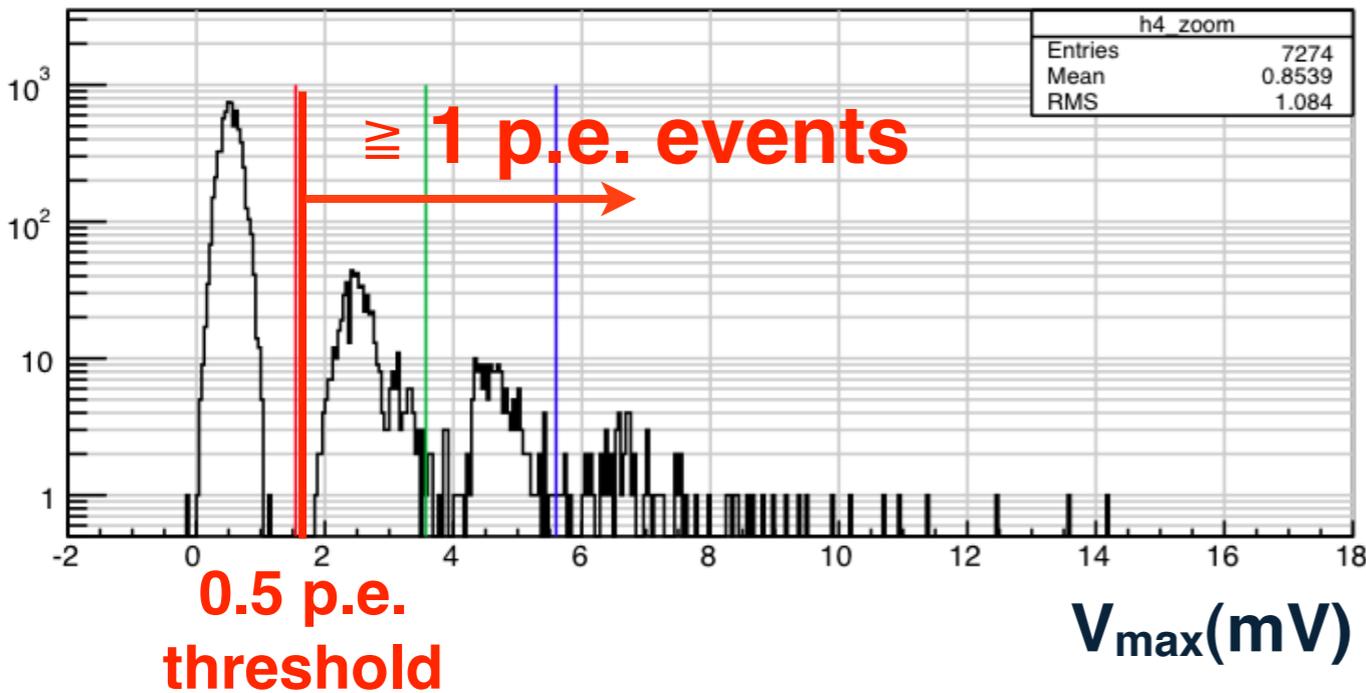
Dark Count

Take 100-ns long waveforms with random trigger
take the maximum of averaged waveform

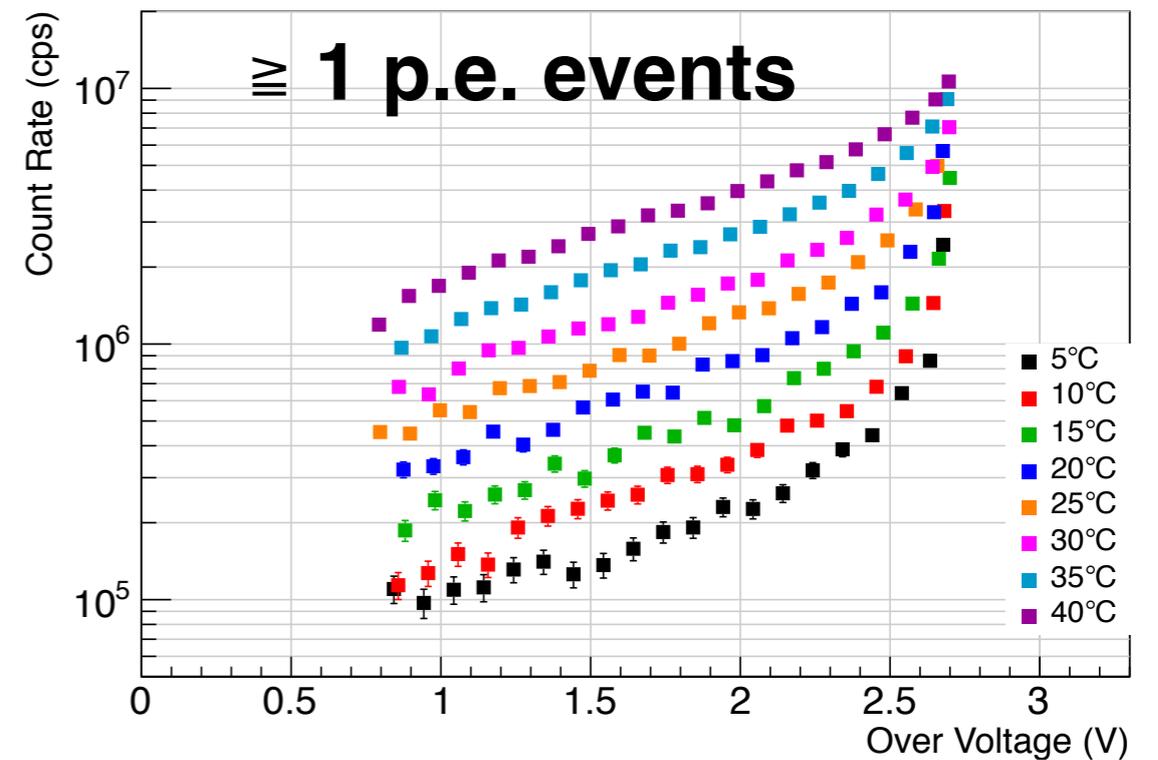


Dark Count

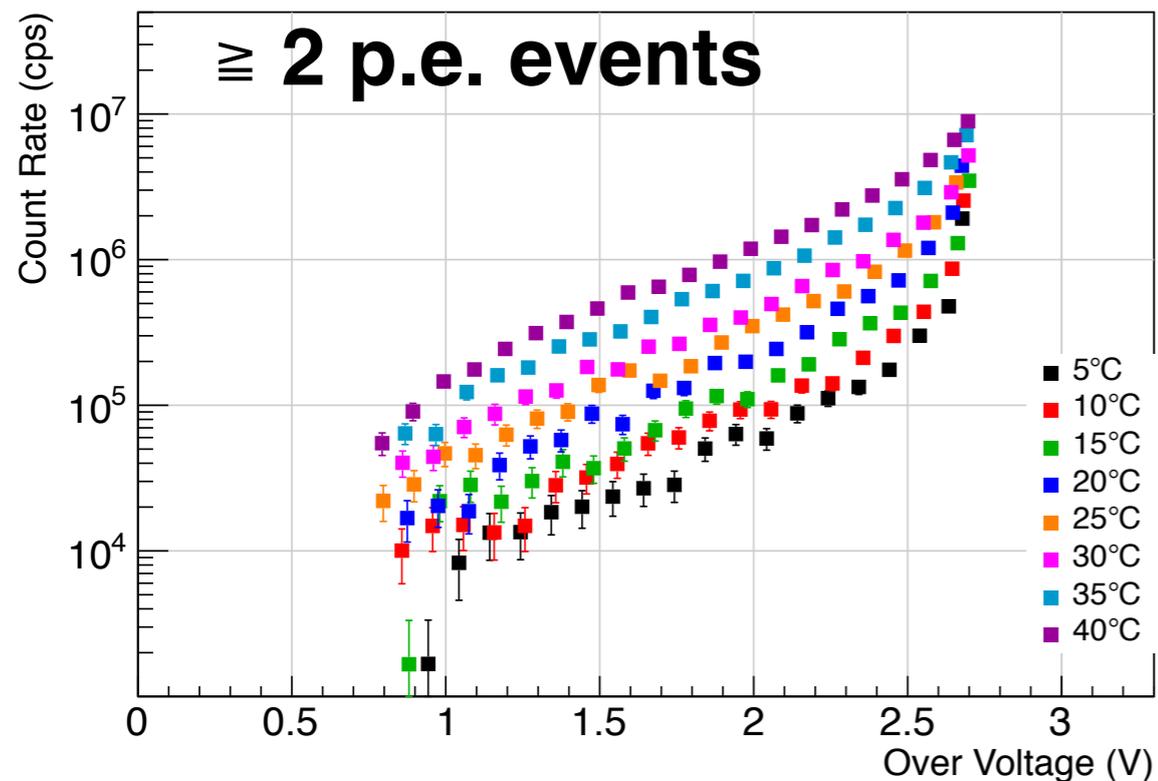
maximum voltage at $10 \text{ ns} \leq \text{time} \leq 90 \text{ ns}$



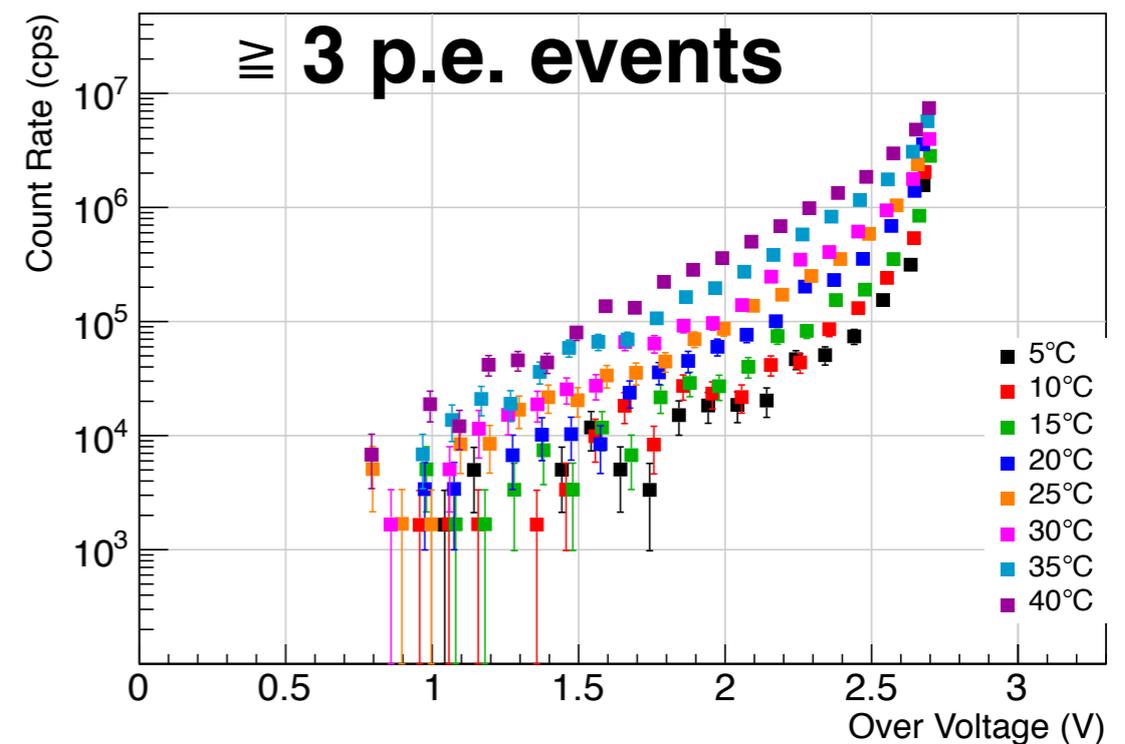
Dark Rate at threshold 0.5p.e. vs Bias Voltage



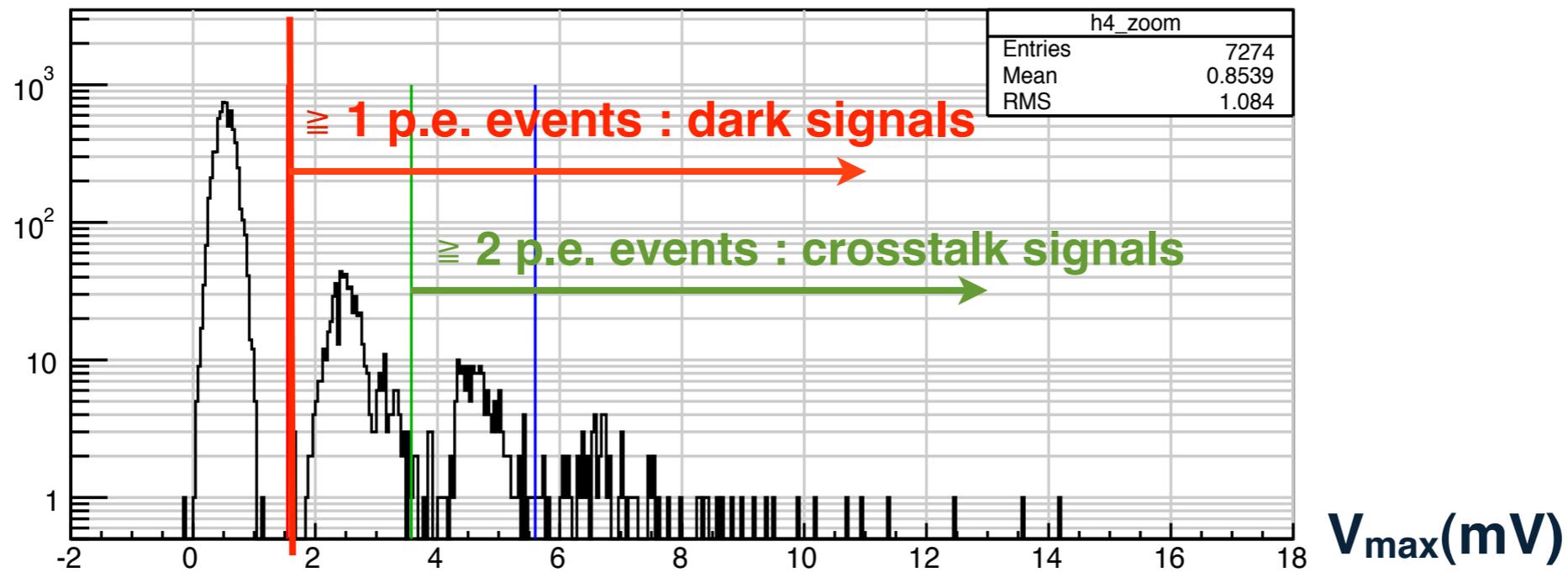
Dark Rate at threshold 1.5p.e. vs Bias Voltage



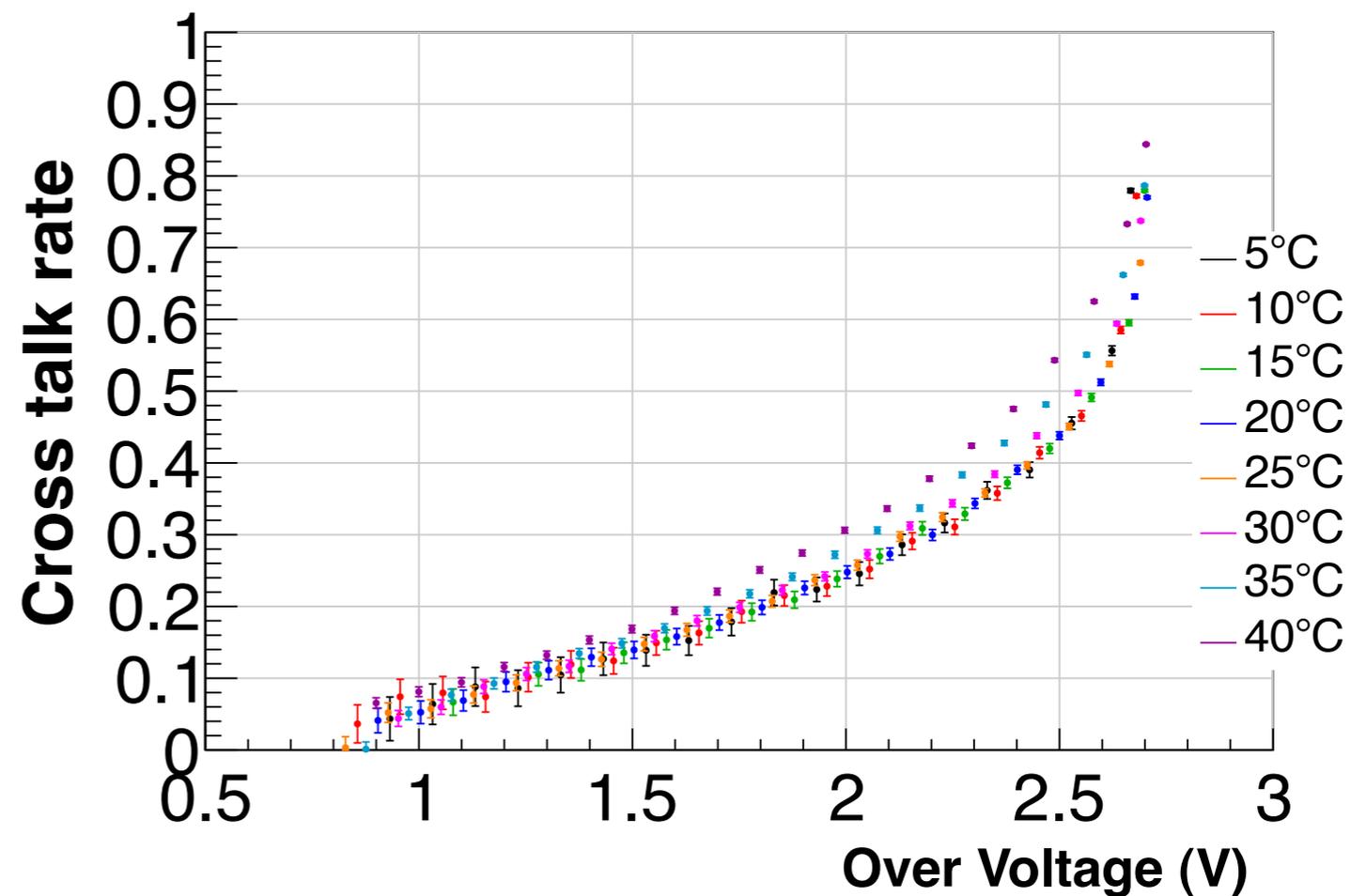
Dark Rate at threshold 2.5p.e. vs Bias Voltage



Crosstalk

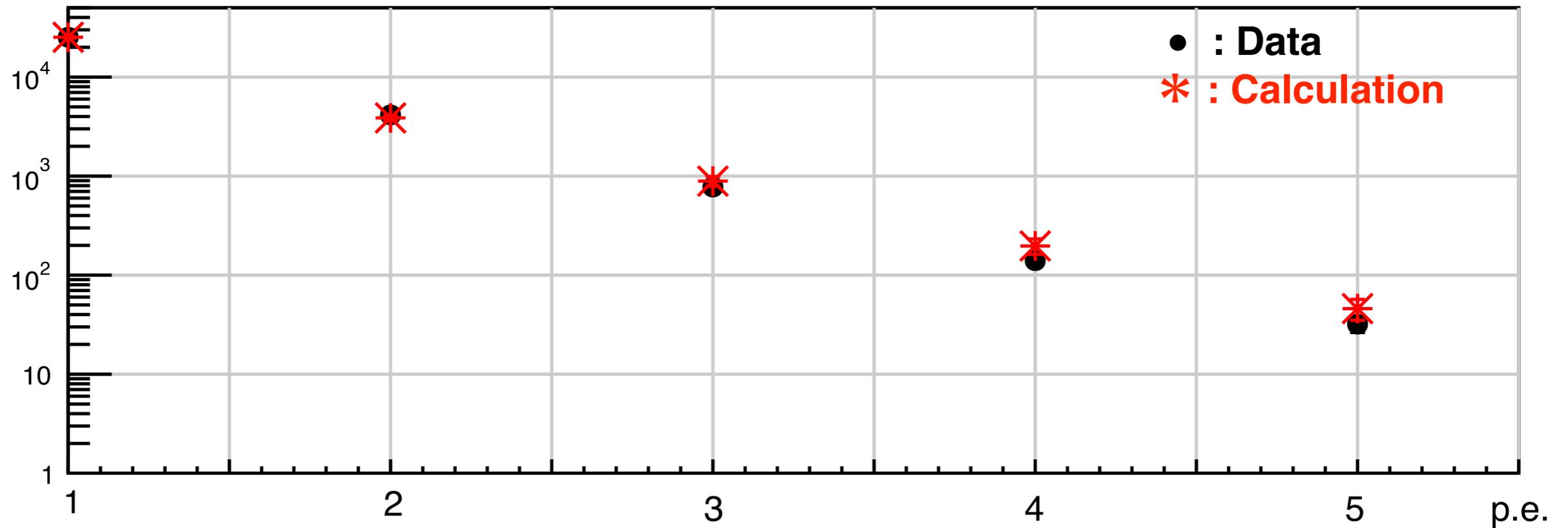


- **Cross talk rate**
= 2 p.e. events / 1 p.e. events
- **No temperature dependence**



Compared with data

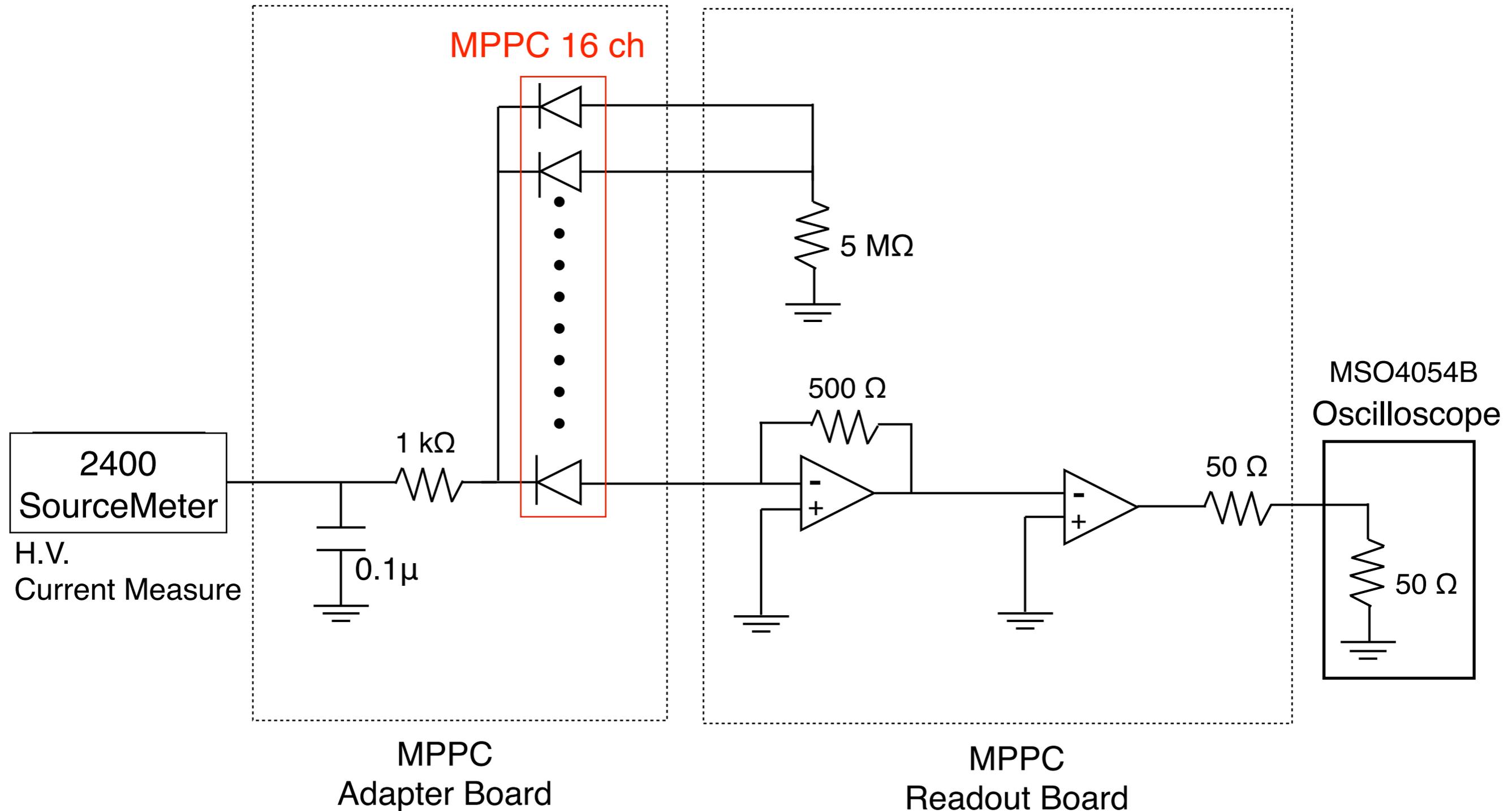
Counts



good agreement → pulse height distribution can be calculated

MPPC Readout

Current sensitive amp



Sensitivity of CTA

order of magnitude improvement in sensitivity over HESS and VERITAS

